

# Am29LV642D

## Data Sheet



RETIRED  
PRODUCT

This product has been retired and is not recommended for designs. For new designs, S29GL128N supersedes Am29LV642D. Please refer to the S29GL-N family data sheet for specifications and ordering information. Availability of this document is retained for reference and historical purposes only.

The following document contains information on Spansion memory products.

### **Continuity of Specifications**

There is no change to this data sheet as a result of offering the device as a Spansion product. Any changes that have been made are the result of normal data sheet improvement and are noted in the document revision summary.

### **For More Information**

Please contact your local sales office for additional information about Spansion memory solutions.



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# Am29LV642D

## 128 Megabit (8 M x 16-Bit) CMOS 3.0 Volt-only Uniform Sector Flash Memory with Versatile/O™ Control

This product has been retired and is not recommended for designs. For new designs, S29GL128N supersedes Am29LV642D. Please refer to the S29GL-N family data sheet for specifications and ordering information. Availability of this document is retained for reference and historical purposes only.

### DISTINCTIVE CHARACTERISTICS

- **Two 64 Megabit (Am29LV640D) in a single 64-ball 13 x 11 mm Fortified BGA package (Note: Features will be described for each internal Am29LV640D)**
- **Two Chip Enable pins**
  - Two CE# pins to control selection of each internal Am29LV640D devices
- **Single power supply operation**
  - 3.0 to 3.6 volt read, erase, and program operations
- **Versatile/O™ control**
  - Device generates data output voltages and tolerates data input voltages as determined by the voltage on the V<sub>IO</sub> pin
- **High performance**
  - Access times as fast as 90 ns
- **Manufactured on 0.23 µm process technology**
- **CFI (Common Flash Interface) compliant**
  - Provides device-specific information to the system, allowing host software to easily reconfigure for different Flash devices
- **Ultra low power consumption (typical values at 3.0 V, 5 MHz) for the part**
  - 9 mA typical active read current
  - 26 mA typical erase/program current
  - 400 nA typical standby mode current
- **Flexible sector architecture**
  - Two hundred fifty-six 32 Kword sectors
- **Sector Protection**
  - A hardware method to lock a sector to prevent program or erase operations within that sector
  - Sectors can be locked in-system or via programming equipment
  - Temporary Sector Unprotect feature allows code changes in previously locked sectors
- **Embedded Algorithms**
  - Embedded Erase algorithm automatically preprograms and erases the entire chip or any combination of designated sectors
  - Embedded Program algorithm automatically writes and verifies data at specified addresses
- **Compatibility with JEDEC standards**
  - Except for the additional CE2# pin, the Fortified BGA is pinout and software compatible with single-power supply Flash
  - Superior inadvertent write protection
- **Minimum 1 million erase cycle guarantee per sector**
- **64-ball Fortified BGA Package**
- **Erase Suspend/Erase Resume**
  - Suspends an erase operation to read data from, or program data to, a sector that is not being erased, then resumes the erase operation
- **Data# Polling and toggle bits**
  - Provides a software method of detecting program or erase operation completion
- **Unlock Bypass Program command**
  - Reduces overall programming time when issuing multiple program command sequences
- **Ready/Busy# pin (RY/BY#)**
  - Provides a hardware method of detecting program or erase cycle completion
- **Hardware reset pin (RESET#)**
  - Hardware method to reset the device for reading array data
- **ACC pin**
  - Accelerates programming time for higher throughput during system production
- **Program and Erase Performance (V<sub>HH</sub> not applied to the ACC input pin)**
  - Word program time: 11 µs typical
  - Sector erase time: 1.6 s typical for each 32 Kword sector
- **20-year data retention at 125°C**
  - Reliable operation for the life of the system

## GENERAL DESCRIPTION

The Am29LV642D is a 128 Mbit, 3.0 Volt (3.0 V to 3.6 V) single power supply flash memory device organized as two Am29LV640D dice in a single 64-ball Fortified BGA package. Each Am29LV640D is a 64 Mbit, 3.0 Volt (3.0 V to 3.6 V) single power supply flash memory device organized as 4,194,304 words. Data appears on DQ0-DQ15. The device is designed to be programmed in-system with the standard system 3.0 volt  $V_{CC}$  supply. A 12.0 volt  $V_{PP}$  is not required for program or erase operations. The Am29LV642D is equipped with two CE# pins for flexible selection between the two internal 64 Mb devices. The device can also be programmed in standard EPROM programmers.

The Am29LV642D offers access times of 90 and 120 ns and is offered in a 64-ball Fortified BGA package. To eliminate bus contention the Am29LV642D device has two separate chip enables (CE# and CE2#). Each chip enable (CE# or CE2#) is connected to only one of the two dice in the Am29LV642D package. **To the system, this device will be the same as two independent Am29LV640D on the same board. The only difference is that they are now packaged together to reduce board space.**

Each device requires only a **single 3.0 Volt power supply** (3.0 V to 3.6 V) for both read and write functions. Internally generated and regulated voltages are provided for the program and erase operations.

The device is entirely command set compatible with the **JEDEC single-power-supply Flash standard**. Commands are written to the command register using standard microprocessor write timing. Register contents serve as inputs to an internal state-machine that controls the erase and programming circuitry. Write cycles also internally latch addresses and data needed for the programming and erase operations. Reading data out of the device is similar to reading from other Flash or EPROM devices.

Device programming occurs by executing the program command sequence. This initiates the **Embedded Program** algorithm—an internal algorithm that automatically times the program pulse widths and verifies proper cell margin. The Unlock Bypass mode facilitates faster programming times by requiring only two write cycles to program data instead of four.

Device erasure occurs by executing the erase command sequence. This initiates the **Embedded Erase** algorithm—an internal algorithm that automatically preprograms the array (if it is not already programmed) before executing the erase operation. During erase, the device automatically times the erase pulse widths and verifies proper cell margin.

The **VersatileI/O™** ( $V_{IO}$ ) control allows the host system to set the voltage levels that the device generates

at its data outputs and the voltages tolerated at its data inputs to the same voltage level that is asserted on the  $V_{IO}$  pin. This allows the device to operate in 1.8 V, 3 V, or 5 V system environment as required. For voltage levels below 3 V, contact an AMD representative for more information.

The host system can detect whether a program or erase operation is complete by observing the RY/BY# pin, by reading the DQ7 (Data# Polling), or DQ6 (toggle) **status bits**. After a program or erase cycle has been completed, the device is ready to read array data or accept another command.

The **sector erase architecture** allows memory sectors to be erased and reprogrammed without affecting the data contents of other sectors. The device is fully erased when shipped from the factory.

**Hardware data protection** measures include a low  $V_{CC}$  detector that automatically inhibits write operations during power transitions. The hardware sector protection feature disables both program and erase operations in any combination of sectors of memory. This can be achieved in-system or via programming equipment.

The **Erase Suspend/Erase Resume** feature enables the user to put erase on hold for any period of time to read data from, or program data to, any sector that is not selected for erasure. True background erase can thus be achieved.

The **hardware RESET# pin** terminates any operation in progress and resets the internal state machine to reading array data. The RESET# pin may be tied to the system reset circuitry. A system reset would thus also reset the device, enabling the system microprocessor to read boot-up firmware from the Flash memory device.

The device offers a **standby mode** as a power-saving feature. Once the system places the device into the standby mode power consumption is greatly reduced.

The **accelerated program (ACC)** feature allows the system to program the device at a much faster rate. When ACC is pulled high to  $V_{HH}$ , the device enters the Unlock Bypass mode, enabling the user to reduce the time needed to do the program operation. This feature is intended to increase factory throughput during system production, but may also be used in the field if desired.

AMD's Flash technology combines years of Flash memory manufacturing experience to produce the highest levels of quality, reliability and cost effectiveness. The device electrically erases all bits within a sector simultaneously via Fowler-Nordheim tunnelling. The data is programmed using hot electron injection.

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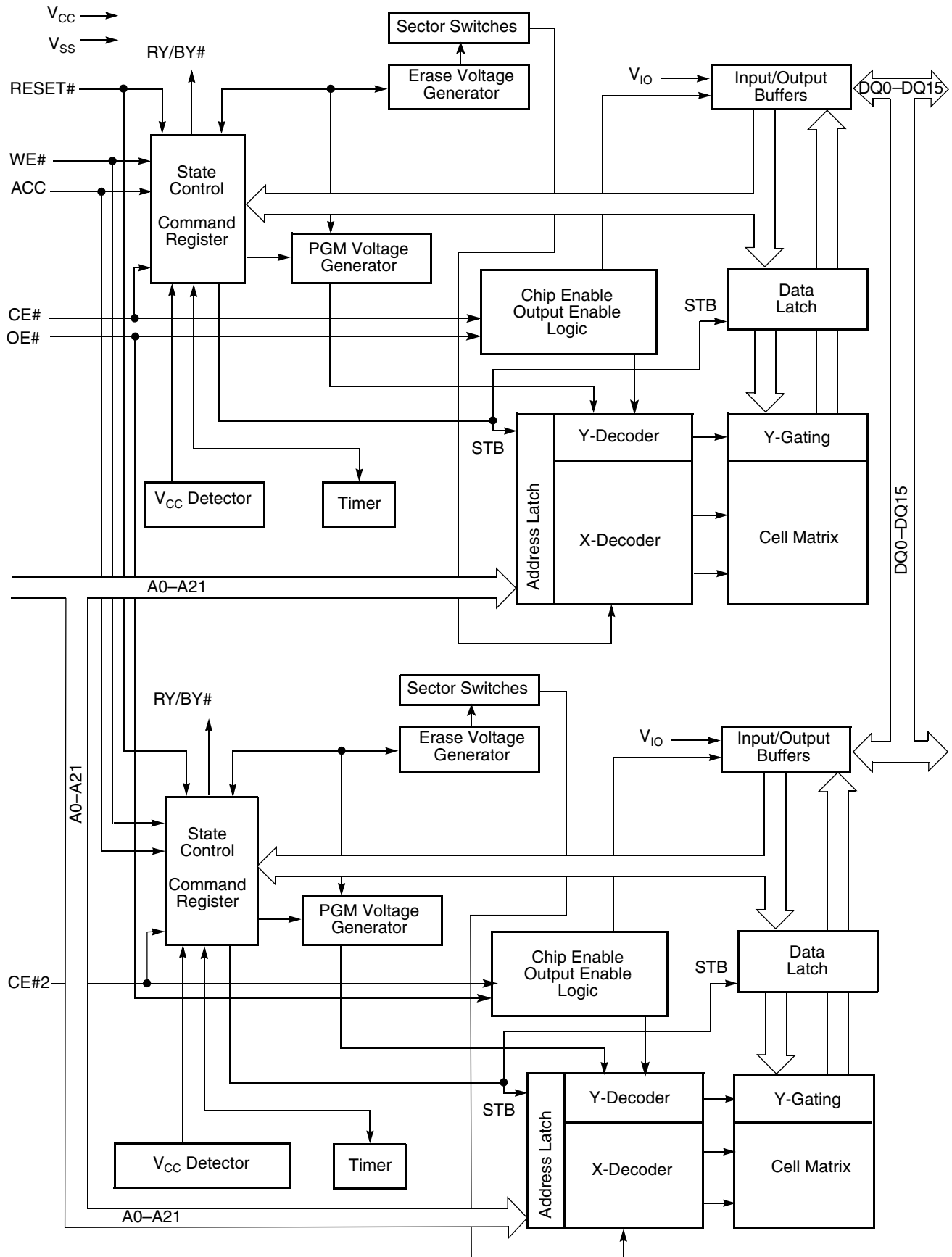
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## PRODUCT SELECTOR GUIDE

| Part Number          |                                                              | Am29LV642D |     |
|----------------------|--------------------------------------------------------------|------------|-----|
| Speed Option         | Regulated Voltage Range: $V_{CC} = 3.0\text{--}3.6\text{ V}$ | 90R        | 12R |
| Max Access Time (ns) |                                                              | 90         | 120 |
| CE# Access Time (ns) |                                                              | 90         | 120 |
| OE# Access Time (ns) |                                                              | 35         | 50  |

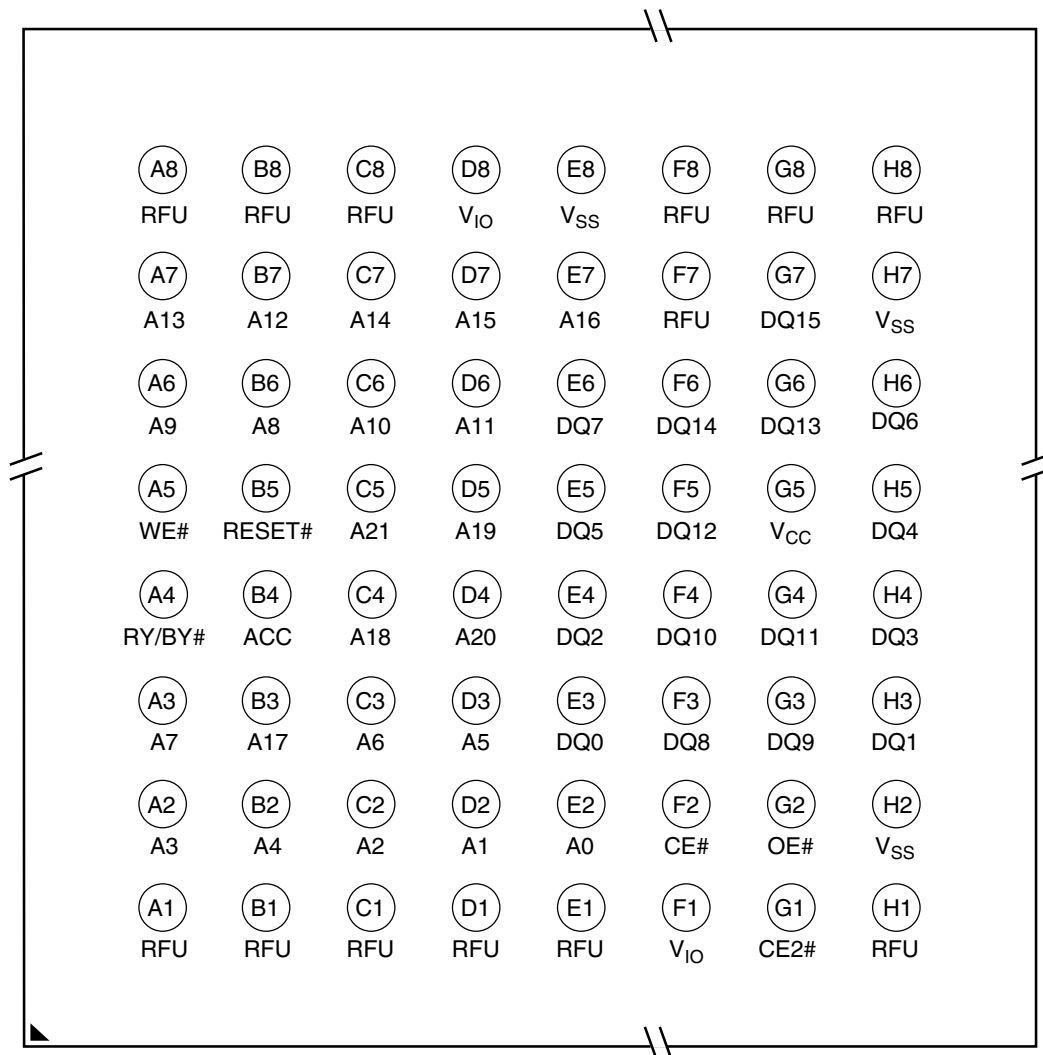
**Note:** See “AC Characteristics” for full specifications.

## BLOCK DIAGRAM



## CONNECTION DIAGRAM

**64-Ball Fortified BGA**  
Top View, Balls Facing Down



### Special Handling Instructions for Fortified BGA Package

Special handling is required for Flash Memory products in Fortified BGA packages.

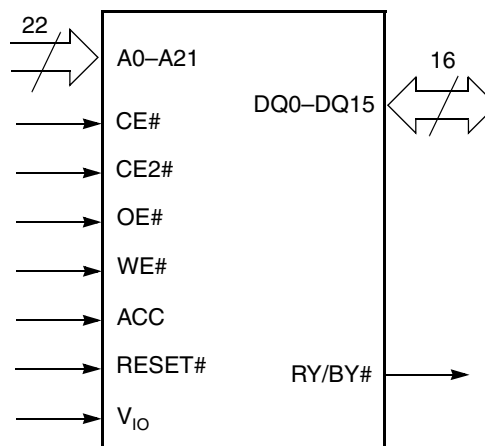
Flash memory devices in Fortified BGA packages may be damaged if exposed to ultrasonic cleaning methods. The package and/or data integrity may be compromised if the package body is exposed to temperatures above 150°C for prolonged periods of time.



## PIN DESCRIPTION

|                 |                                                                                                                           |
|-----------------|---------------------------------------------------------------------------------------------------------------------------|
| A0–A21          | = 22 Addresses inputs                                                                                                     |
| DQ0–DQ15        | = 16 Data inputs/outputs                                                                                                  |
| CE#             | = Chip Enable input                                                                                                       |
| CE2#            | = Chip Enable input for second die                                                                                        |
| OE#             | = Output Enable input                                                                                                     |
| WE#             | = Write Enable input                                                                                                      |
| ACC             | = Acceleration Input                                                                                                      |
| RESET#          | = Hardware Reset Pin input                                                                                                |
| RY/BY#          | = Ready/Busy output                                                                                                       |
| V <sub>CC</sub> | = 3.0 volt-only single power supply<br>(see Product Selector Guide for<br>speed options and voltage<br>supply tolerances) |
| V <sub>IO</sub> | = Output Buffer power                                                                                                     |
| V <sub>SS</sub> | = Device Ground                                                                                                           |
| NC              | = Pin Not Connected Internally                                                                                            |

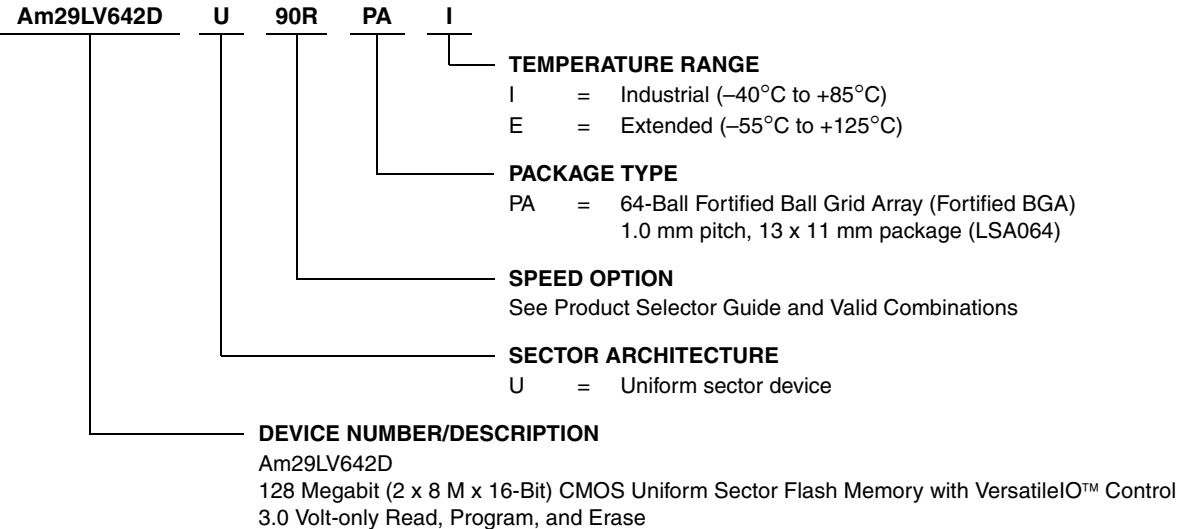
## LOGIC SYMBOL



ORDERING INFORMATION

Standard Products

AMD standard products are available in several packages and operating ranges. The order number (Valid Combination) is formed by a combination of the following:



| Valid Combinations for Fortified BGA Packages |          |                 |      | Speed/<br>V <sub>IO</sub> Range         |
|-----------------------------------------------|----------|-----------------|------|-----------------------------------------|
| Order Number                                  |          | Package Marking |      |                                         |
| Am29LV642DU90R                                | PAI      | L642DU90R       | I    | 90 ns, V <sub>IO</sub> = 3.0 V – 5.0 V  |
| Am29LV642DU12R                                | PAI, PAE | L642DU12R       | I, E | 120 ns, V <sub>IO</sub> = 3.0 V – 5.0 V |

Valid Combinations

Valid Combinations list configurations planned to be supported in volume for this device. Consult the local AMD sales office to confirm availability of specific valid combinations and to check on newly released combinations.

## DEVICE BUS OPERATIONS

This section describes the requirements and use of the device bus operations, which are initiated through the internal command register. The command register itself does not occupy any addressable memory location. The register is a latch used to store the commands, along with the address and data information needed to execute the command. The contents of the

register serve as inputs to the internal state machine. The state machine outputs dictate the function of the device. Table 1 lists the device bus operations, the inputs and control levels they require, and the resulting output. The following subsections describe each of these operations in further detail.

**Table 1. Am29LV642D Device Bus Operations**

| Operation                           | CE#<br>(Note 1)         | OE# | WE# | RESET#                  | ACC             | Addresses<br>(Note 2)         | DQ0–DQ15         |
|-------------------------------------|-------------------------|-----|-----|-------------------------|-----------------|-------------------------------|------------------|
| Read                                | L                       | L   | H   | H                       | X               | A <sub>IN</sub>               | D <sub>OUT</sub> |
| Write (Program/Erase)               | L                       | H   | L   | H                       | X               | A <sub>IN</sub>               | (Note 3)         |
| Accelerated Program                 | L                       | H   | L   | H                       | V <sub>HH</sub> | A <sub>IN</sub>               | (Note 3)         |
| Standby                             | V <sub>CC</sub> ± 0.3 V | X   | X   | V <sub>CC</sub> ± 0.3 V | H               | X                             | High-Z           |
| Output Disable                      | L                       | H   | H   | H                       | X               | X                             | High-Z           |
| Reset                               | X                       | X   | X   | L                       | X               | X                             | High-Z           |
| Sector Group Protect (Note 4)       | L                       | H   | L   | V <sub>ID</sub>         | X               | SA, A6 = L,<br>A1 = H, A0 = L | (Note 3)         |
| Sector Group Unprotect<br>(Note 4)  | L                       | H   | L   | V <sub>ID</sub>         | X               | SA, A6 = H,<br>A1 = H, A0 = L | (Note 3)         |
| Temporary Sector Group<br>Unprotect | X                       | X   | X   | V <sub>ID</sub>         | X               | A <sub>IN</sub>               | (Note 3)         |

**Legend:** L = Logic Low = V<sub>IL</sub>, H = Logic High = V<sub>IH</sub>, V<sub>ID</sub> = 8.5–12.5 V, V<sub>HH</sub> = 11.5–12.5 V, X = Don't Care, SA = Sector Address, A<sub>IN</sub> = Address In, D<sub>IN</sub> = Data In, D<sub>OUT</sub> = Data Out

### Notes:

1. CE# can be replaced with CE2# when referring to the second die in the package. CE# and CE2# must not both be driven at the same time.
2. Addresses are A21:A0. Sector addresses are A21:A15.
3. D<sub>IN</sub> or D<sub>OUT</sub> as required by command sequence, data polling, or sector protect algorithm (see Figure 2).
4. The sector protect and sector unprotect functions may also be implemented via programming equipment. See the "Sector Group Protection and Unprotection" section.
5. All sectors are unprotected when shipped from the factory.

## Versatile/I/O™ (V<sub>IO</sub>) Control

The Versatile/I/O (V<sub>IO</sub>) control allows the host system to set the voltage levels that the device generates at its data outputs and the voltages tolerated at its data inputs to the same voltage level that is asserted on the V<sub>IO</sub> pin. This allows the device to operate in 1.8 V, 3 V, or 5 V system environment as required. For voltage levels below 3 V, contact an AMD representative for more information.

For example, a V<sub>IO</sub> of 4.5–5.5 volts allows for I/O at the 5 volt level, driving and receiving signals to and from other 5 V devices on the same bus.

## Requirements for Reading Array Data

To read array data from the outputs, the system must drive the CE# or CE2# and OE# pins to V<sub>IL</sub>. CE# or CE2# is the power control and selects the device. OE# is the output control and gates array data to the output pins. WE# should remain at V<sub>IH</sub>.

The internal state machine is set for reading array data upon device power-up, or after a hardware reset. This ensures that no spurious alteration of the memory content occurs during the power transition. No command is necessary in this mode to obtain array data. Standard microprocessor read cycles that assert valid addresses on the device address inputs produce valid data on the device data outputs. The device remains

enabled for read access until the command register contents are altered.

See “Versatile/O™ ( $V_{IO}$ ) Control” for more information. Refer to the AC Read-Only Operations table for timing specifications and to Figure 13 for the timing diagram.  $I_{CC1}$  in the DC Characteristics table represents the active current specification for reading array data.

## Writing Commands/Command Sequences

To write a command or command sequence (which includes programming data to the device and erasing sectors of memory), the system must drive  $WE\#$  and  $CE\#$  (or  $CE2\#$ ) to  $V_{IL}$ , and  $OE\#$  to  $V_{IH}$ .

The device features an **Unlock Bypass** mode to facilitate faster programming. Once the device enters the Unlock Bypass mode, only two write cycles are required to program a word, instead of four. The “Word Program Command Sequence” section has details on programming data to the device using both standard and Unlock Bypass command sequences.

An erase operation can erase one sector, multiple sectors, or the entire device. Table 2 indicates the address space that each sector occupies.

$I_{CC2}$  in the DC Characteristics table represents the active current specification for the write mode. The AC Characteristics section contains timing specification tables and timing diagrams for write operations.

## Accelerated Program Operation

The device offers accelerated program operations through the ACC function. This function is primarily intended to allow faster manufacturing throughput during system production.

If the system asserts  $V_{HH}$  on this pin, the device automatically enters the aforementioned Unlock Bypass mode, temporarily unprotects any protected sectors, and uses the higher voltage on the pin to reduce the time required for program operations. The system would use a two-cycle program command sequence as required by the Unlock Bypass mode. Removing  $V_{HH}$  from the ACC pin returns the device to normal operation. *Note that the ACC pin must not be at  $V_{HH}$  for operations other than accelerated programming, or device damage may result.*

## Autoselect Functions

If the system writes the autoselect command sequence, the device enters the autoselect mode. The system can then read autoselect codes from the internal register (which is separate from the memory array) on DQ15–DQ0. Standard read cycle timings apply in this mode. Refer to the Autoselect Mode and Autoselect Command Sequence sections for more information.

## Standby Mode

When the system is not reading or writing to the device, it can place the device in the standby mode. In this mode, current consumption is greatly reduced, and the outputs are placed in the high impedance state, independent of the  $OE\#$  input.

The device enters the CMOS standby mode when the  $CE\#$ ,  $CE2\#$ , and  $RESET\#$  pins are all held at  $V_{CC} \pm 0.3$  V. (Note that this is a more restricted voltage range than  $V_{IH}$ .) If  $CE\#$ ,  $CE2\#$ , and  $RESET\#$  are held at  $V_{IH}$ , but not within  $V_{CC} \pm 0.3$  V, the device will be in the standby mode, but the standby current will be greater. The device requires standard access time ( $t_{CE}$ ) for read access when the device is in either of these standby modes, before it is ready to read data.

If the device is deselected during erasure or programming, the device draws active current until the operation is completed.

$I_{CC3}$  in the DC Characteristics (for Two Am29LV640 devices) table represents the standby current specification.

## Automatic Sleep Mode

The automatic sleep mode minimizes Flash device energy consumption. The device automatically enables this mode when addresses remain stable for  $t_{ACC} + 30$  ns. The automatic sleep mode is independent of the  $CE\#$ ,  $CE2\#$ ,  $WE\#$ , and  $OE\#$  control signals. Standard address access timings provide new data when addresses are changed. While in sleep mode, output data is latched and always available to the system.  $I_{CC4}$  in the DC Characteristics (for Two Am29LV640 devices) table represents the automatic sleep mode current specification.

## RESET#: Hardware Reset Pin

The  $RESET\#$  pin provides a hardware method of resetting the device to reading array data. When the  $RESET\#$  pin is driven low for at least a period of  $t_{RP}$ , the device immediately terminates any operation in progress, tristates all output pins, and ignores all read/write commands for the duration of the  $RESET\#$  pulse. The device also resets the internal state machine to reading array data. The operation that was interrupted should be reinitiated once the device is ready to accept another command sequence, to ensure data integrity.

Current is reduced for the duration of the  $RESET\#$  pulse. When  $RESET\#$  is held at  $V_{SS} \pm 0.3$  V, the device draws CMOS standby current ( $I_{CC4}$ ). If  $RESET\#$  is held at  $V_{IL}$  but not within  $V_{SS} \pm 0.3$  V, the standby current will be greater.

The  $RESET\#$  pin may be tied to the system reset circuitry. A system reset would thus also reset the Flash

memory, enabling the system to read the boot-up firmware from the Flash memory.

If RESET# is asserted during a program or erase operation, the RY/BY# pin remains a “0” (busy) until the internal reset operation is complete, which requires a time of  $t_{\text{READY}}$  (during Embedded Algorithms). The system can thus monitor RY/BY# to determine whether the reset operation is complete. If RESET# is asserted when a program or erase operation is not executing (RY/BY# pin is “1”), the reset operation is completed within a time of  $t_{\text{READY}}$  (not during Embedded Algo-

rithms). The system can read data  $t_{\text{RH}}$  after the RESET# pin returns to  $V_{\text{IH}}$ .

Refer to the AC Characteristics tables for RESET# parameters and to Figure 14 for the timing diagram.

### Output Disable Mode

When the OE# input is at  $V_{\text{IH}}$ , output from the device is disabled. The output pins are placed in the high impedance state.

**Table 2. Sector Address Table for CE#**

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA0    | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 000000–007FFF                            |
| SA1    | 0   | 0   | 0   | 0   | 0   | 0   | 1   | 008000–00FFFF                            |
| SA2    | 0   | 0   | 0   | 0   | 0   | 1   | 0   | 010000–017FFF                            |
| SA3    | 0   | 0   | 0   | 0   | 0   | 1   | 1   | 018000–01FFFF                            |
| SA4    | 0   | 0   | 0   | 0   | 1   | 0   | 0   | 020000–027FFF                            |
| SA5    | 0   | 0   | 0   | 0   | 1   | 0   | 1   | 028000–02FFFF                            |
| SA6    | 0   | 0   | 0   | 0   | 1   | 1   | 0   | 030000–037FFF                            |
| SA7    | 0   | 0   | 0   | 0   | 1   | 1   | 1   | 038000–03FFFF                            |
| SA8    | 0   | 0   | 0   | 1   | 0   | 0   | 0   | 040000–047FFF                            |
| SA9    | 0   | 0   | 0   | 1   | 0   | 0   | 1   | 048000–04FFFF                            |
| SA10   | 0   | 0   | 0   | 1   | 0   | 1   | 0   | 050000–057FFF                            |
| SA11   | 0   | 0   | 0   | 1   | 0   | 1   | 1   | 058000–05FFFF                            |
| SA12   | 0   | 0   | 0   | 1   | 1   | 0   | 0   | 060000–067FFF                            |
| SA13   | 0   | 0   | 0   | 1   | 1   | 0   | 1   | 068000–06FFFF                            |
| SA14   | 0   | 0   | 0   | 1   | 1   | 1   | 0   | 070000–077FFF                            |
| SA15   | 0   | 0   | 0   | 1   | 1   | 1   | 1   | 078000–07FFFF                            |
| SA16   | 0   | 0   | 1   | 0   | 0   | 0   | 0   | 080000–087FFF                            |
| SA17   | 0   | 0   | 1   | 0   | 0   | 0   | 1   | 088000–08FFFF                            |
| SA18   | 0   | 0   | 1   | 0   | 0   | 1   | 0   | 090000–097FFF                            |
| SA19   | 0   | 0   | 1   | 0   | 0   | 1   | 1   | 098000–09FFFF                            |
| SA20   | 0   | 0   | 1   | 0   | 1   | 0   | 0   | 0A0000–0A7FFF                            |
| SA21   | 0   | 0   | 1   | 0   | 1   | 0   | 1   | 0A8000–0AFFFF                            |
| SA22   | 0   | 0   | 1   | 0   | 1   | 1   | 0   | 0B0000–0B7FFF                            |
| SA23   | 0   | 0   | 1   | 0   | 1   | 1   | 1   | 0B8000–0BFFFF                            |
| SA24   | 0   | 0   | 1   | 1   | 0   | 0   | 0   | 0C0000–0C7FFF                            |
| SA25   | 0   | 0   | 1   | 1   | 0   | 0   | 1   | 0C8000–0CFFFF                            |

Table 2. Sector Address Table for CE# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA26   | 0   | 0   | 1   | 1   | 0   | 1   | 0   | 0D0000–0D7FFF                            |
| SA27   | 0   | 0   | 1   | 1   | 0   | 1   | 1   | 0D8000–0DFFFF                            |
| SA28   | 0   | 0   | 1   | 1   | 1   | 0   | 0   | 0E0000–0E7FFF                            |
| SA29   | 0   | 0   | 1   | 1   | 1   | 0   | 1   | 0E8000–0EFFFF                            |
| SA30   | 0   | 0   | 1   | 1   | 1   | 1   | 0   | 0F0000–0F7FFF                            |
| SA31   | 0   | 0   | 1   | 1   | 1   | 1   | 1   | 0F8000–0FFFFF                            |
| SA32   | 0   | 1   | 0   | 0   | 0   | 0   | 0   | 100000–107FFF                            |
| SA33   | 0   | 1   | 0   | 0   | 0   | 0   | 1   | 108000–10FFFF                            |
| SA34   | 0   | 1   | 0   | 0   | 0   | 1   | 0   | 110000–117FFF                            |
| SA35   | 0   | 1   | 0   | 0   | 0   | 1   | 1   | 118000–11FFFF                            |
| SA36   | 0   | 1   | 0   | 0   | 1   | 0   | 0   | 120000–127FFF                            |
| SA37   | 0   | 1   | 0   | 0   | 1   | 0   | 1   | 128000–12FFFF                            |
| SA38   | 0   | 1   | 0   | 0   | 1   | 1   | 0   | 130000–137FFF                            |
| SA39   | 0   | 1   | 0   | 0   | 1   | 1   | 1   | 138000–13FFFF                            |
| SA40   | 0   | 1   | 0   | 1   | 0   | 0   | 0   | 140000–147FFF                            |
| SA41   | 0   | 1   | 0   | 1   | 0   | 0   | 1   | 148000–14FFFF                            |
| SA42   | 0   | 1   | 0   | 1   | 0   | 1   | 0   | 150000–157FFF                            |
| SA43   | 0   | 1   | 0   | 1   | 0   | 1   | 1   | 158000–15FFFF                            |
| SA44   | 0   | 1   | 0   | 1   | 1   | 0   | 0   | 160000–167FFF                            |
| SA45   | 0   | 1   | 0   | 1   | 1   | 0   | 1   | 168000–16FFFF                            |
| SA46   | 0   | 1   | 0   | 1   | 1   | 1   | 0   | 170000–177FFF                            |
| SA47   | 0   | 1   | 0   | 1   | 1   | 1   | 1   | 178000–17FFFF                            |
| SA48   | 0   | 1   | 1   | 0   | 0   | 0   | 0   | 180000–187FFF                            |
| SA49   | 0   | 1   | 1   | 0   | 0   | 0   | 1   | 188000–18FFFF                            |
| SA50   | 0   | 1   | 1   | 0   | 0   | 1   | 0   | 190000–197FFF                            |
| SA51   | 0   | 1   | 1   | 0   | 0   | 1   | 1   | 198000–19FFFF                            |
| SA52   | 0   | 1   | 1   | 0   | 1   | 0   | 0   | 1A0000–1A7FFF                            |
| SA53   | 0   | 1   | 1   | 0   | 1   | 0   | 1   | 1A8000–1AFFFF                            |
| SA54   | 0   | 1   | 1   | 0   | 1   | 1   | 0   | 1B0000–1B7FFF                            |
| SA55   | 0   | 1   | 1   | 0   | 1   | 1   | 1   | 1B8000–1BFFFF                            |
| SA56   | 0   | 1   | 1   | 1   | 0   | 0   | 0   | 1C0000–1C7FFF                            |
| SA57   | 0   | 1   | 1   | 1   | 0   | 0   | 1   | 1C8000–1CFFFF                            |
| SA58   | 0   | 1   | 1   | 1   | 0   | 1   | 0   | 1D0000–1D7FFF                            |
| SA59   | 0   | 1   | 1   | 1   | 0   | 1   | 1   | 1D8000–1DFFFF                            |
| SA60   | 0   | 1   | 1   | 1   | 1   | 0   | 0   | 1E0000–1E7FFF                            |

Table 2. Sector Address Table for CE# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA61   | 0   | 1   | 1   | 1   | 1   | 0   | 1   | 1E8000–1EFFFF                            |
| SA62   | 0   | 1   | 1   | 1   | 1   | 1   | 0   | 1F0000–1F7FFF                            |
| SA63   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1F8000–1FFFFFF                           |
| SA64   | 1   | 0   | 0   | 0   | 0   | 0   | 0   | 200000–207FFF                            |
| SA65   | 1   | 0   | 0   | 0   | 0   | 0   | 1   | 208000–20FFFF                            |
| SA66   | 1   | 0   | 0   | 0   | 0   | 1   | 0   | 210000–217FFF                            |
| SA67   | 1   | 0   | 0   | 0   | 0   | 1   | 1   | 218000–21FFFF                            |
| SA68   | 1   | 0   | 0   | 0   | 1   | 0   | 0   | 220000–227FFF                            |
| SA69   | 1   | 0   | 0   | 0   | 1   | 0   | 1   | 228000–22FFFF                            |
| SA70   | 1   | 0   | 0   | 0   | 1   | 1   | 0   | 230000–237FFF                            |
| SA71   | 1   | 0   | 0   | 0   | 1   | 1   | 1   | 238000–23FFFF                            |
| SA72   | 1   | 0   | 0   | 1   | 0   | 0   | 0   | 240000–247FFF                            |
| SA73   | 1   | 0   | 0   | 1   | 0   | 0   | 1   | 248000–24FFFF                            |
| SA74   | 1   | 0   | 0   | 1   | 0   | 1   | 0   | 250000–257FFF                            |
| SA75   | 1   | 0   | 0   | 1   | 0   | 1   | 1   | 258000–25FFFF                            |
| SA76   | 1   | 0   | 0   | 1   | 1   | 0   | 0   | 260000–267FFF                            |
| SA77   | 1   | 0   | 0   | 1   | 1   | 0   | 1   | 268000–26FFFF                            |
| SA78   | 1   | 0   | 0   | 1   | 1   | 1   | 0   | 270000–277FFF                            |
| SA79   | 1   | 0   | 0   | 1   | 1   | 1   | 1   | 278000–27FFFF                            |
| SA80   | 1   | 0   | 1   | 0   | 0   | 0   | 0   | 280000–287FFF                            |
| SA81   | 1   | 0   | 1   | 0   | 0   | 0   | 1   | 288000–28FFFF                            |
| SA82   | 1   | 0   | 1   | 0   | 0   | 1   | 0   | 290000–297FFF                            |
| SA83   | 1   | 0   | 1   | 0   | 0   | 1   | 1   | 298000–29FFFF                            |
| SA84   | 1   | 0   | 1   | 0   | 1   | 0   | 0   | 2A0000–2A7FFF                            |
| SA85   | 1   | 0   | 1   | 0   | 1   | 0   | 1   | 2A8000–2AFFFF                            |
| SA86   | 1   | 0   | 1   | 0   | 1   | 1   | 0   | 2B0000–2B7FFF                            |
| SA87   | 1   | 0   | 1   | 0   | 1   | 1   | 1   | 2B8000–2BFFFF                            |
| SA88   | 1   | 0   | 1   | 1   | 0   | 0   | 0   | 2C0000–2C7FFF                            |
| SA89   | 1   | 0   | 1   | 1   | 0   | 0   | 1   | 2C8000–2CFFFF                            |
| SA90   | 1   | 0   | 1   | 1   | 0   | 1   | 0   | 2D0000–2D7FFF                            |
| SA91   | 1   | 0   | 1   | 1   | 0   | 1   | 1   | 2D8000–2DFFFF                            |
| SA92   | 1   | 0   | 1   | 1   | 1   | 0   | 0   | 2E0000–2E7FFF                            |
| SA93   | 1   | 0   | 1   | 1   | 1   | 0   | 1   | 2E8000–2EFFFF                            |
| SA94   | 1   | 0   | 1   | 1   | 1   | 1   | 0   | 2F0000–2F7FFF                            |
| SA95   | 1   | 0   | 1   | 1   | 1   | 1   | 1   | 2F8000–2FFFFFF                           |

Table 2. Sector Address Table for CE# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA96   | 1   | 1   | 0   | 0   | 0   | 0   | 0   | 300000–307FFF                            |
| SA97   | 1   | 1   | 0   | 0   | 0   | 0   | 1   | 308000–30FFFF                            |
| SA98   | 1   | 1   | 0   | 0   | 0   | 1   | 0   | 310000–317FFF                            |
| SA99   | 1   | 1   | 0   | 0   | 0   | 1   | 1   | 318000–31FFFF                            |
| SA100  | 1   | 1   | 0   | 0   | 1   | 0   | 0   | 320000–327FFF                            |
| SA101  | 1   | 1   | 0   | 0   | 1   | 0   | 1   | 328000–32FFFF                            |
| SA102  | 1   | 1   | 0   | 0   | 1   | 1   | 0   | 330000–337FFF                            |
| SA103  | 1   | 1   | 0   | 0   | 1   | 1   | 1   | 338000–33FFFF                            |
| SA104  | 1   | 1   | 0   | 1   | 0   | 0   | 0   | 340000–347FFF                            |
| SA105  | 1   | 1   | 0   | 1   | 0   | 0   | 1   | 348000–34FFFF                            |
| SA106  | 1   | 1   | 0   | 1   | 0   | 1   | 0   | 350000–357FFF                            |
| SA107  | 1   | 1   | 0   | 1   | 0   | 1   | 1   | 358000–35FFFF                            |
| SA108  | 1   | 1   | 0   | 1   | 1   | 0   | 0   | 360000–367FFF                            |
| SA109  | 1   | 1   | 0   | 1   | 1   | 0   | 1   | 368000–36FFFF                            |
| SA110  | 1   | 1   | 0   | 1   | 1   | 1   | 0   | 370000–377FFF                            |
| SA111  | 1   | 1   | 0   | 1   | 1   | 1   | 1   | 378000–37FFFF                            |
| SA112  | 1   | 1   | 1   | 0   | 0   | 0   | 0   | 380000–387FFF                            |
| SA113  | 1   | 1   | 1   | 0   | 0   | 0   | 1   | 388000–38FFFF                            |
| SA114  | 1   | 1   | 1   | 0   | 0   | 1   | 0   | 390000–397FFF                            |
| SA115  | 1   | 1   | 1   | 0   | 0   | 1   | 1   | 398000–39FFFF                            |
| SA116  | 1   | 1   | 1   | 0   | 1   | 0   | 0   | 3A0000–3A7FFF                            |
| SA117  | 1   | 1   | 1   | 0   | 1   | 0   | 1   | 3A8000–3AFFFF                            |
| SA118  | 1   | 1   | 1   | 0   | 1   | 1   | 0   | 3B0000–3B7FFF                            |
| SA119  | 1   | 1   | 1   | 0   | 1   | 1   | 1   | 3B8000–3BFFFF                            |
| SA120  | 1   | 1   | 1   | 1   | 0   | 0   | 0   | 3C0000–3C7FFF                            |
| SA121  | 1   | 1   | 1   | 1   | 0   | 0   | 1   | 3C8000–3CFFFF                            |
| SA122  | 1   | 1   | 1   | 1   | 0   | 1   | 0   | 3D0000–3D7FFF                            |
| SA123  | 1   | 1   | 1   | 1   | 0   | 1   | 1   | 3D8000–3DFFFF                            |
| SA124  | 1   | 1   | 1   | 1   | 1   | 0   | 0   | 3E0000–3E7FFF                            |
| SA125  | 1   | 1   | 1   | 1   | 1   | 0   | 1   | 3E8000–3EFFFF                            |
| SA126  | 1   | 1   | 1   | 1   | 1   | 1   | 0   | 3F0000–3F7FFF                            |
| SA127  | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 3F8000–3FFFFF                            |

**Note:** All sectors are 32 Kwords in size.



Table 3. Sector Address Table for CE2#

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA0    | 0   | 0   | 0   | 0   | 0   | 0   | 0   | 000000–007FFF                            |
| SA1    | 0   | 0   | 0   | 0   | 0   | 0   | 1   | 008000–00FFFF                            |
| SA2    | 0   | 0   | 0   | 0   | 0   | 1   | 0   | 010000–017FFF                            |
| SA3    | 0   | 0   | 0   | 0   | 0   | 1   | 1   | 018000–01FFFF                            |
| SA4    | 0   | 0   | 0   | 0   | 1   | 0   | 0   | 020000–027FFF                            |
| SA5    | 0   | 0   | 0   | 0   | 1   | 0   | 1   | 028000–02FFFF                            |
| SA6    | 0   | 0   | 0   | 0   | 1   | 1   | 0   | 030000–037FFF                            |
| SA7    | 0   | 0   | 0   | 0   | 1   | 1   | 1   | 038000–03FFFF                            |
| SA8    | 0   | 0   | 0   | 1   | 0   | 0   | 0   | 040000–047FFF                            |
| SA9    | 0   | 0   | 0   | 1   | 0   | 0   | 1   | 048000–04FFFF                            |
| SA10   | 0   | 0   | 0   | 1   | 0   | 1   | 0   | 050000–057FFF                            |
| SA11   | 0   | 0   | 0   | 1   | 0   | 1   | 1   | 058000–05FFFF                            |
| SA12   | 0   | 0   | 0   | 1   | 1   | 0   | 0   | 060000–067FFF                            |
| SA13   | 0   | 0   | 0   | 1   | 1   | 0   | 1   | 068000–06FFFF                            |
| SA14   | 0   | 0   | 0   | 1   | 1   | 1   | 0   | 070000–077FFF                            |
| SA15   | 0   | 0   | 0   | 1   | 1   | 1   | 1   | 078000–07FFFF                            |
| SA16   | 0   | 0   | 1   | 0   | 0   | 0   | 0   | 080000–087FFF                            |
| SA17   | 0   | 0   | 1   | 0   | 0   | 0   | 1   | 088000–08FFFF                            |
| SA18   | 0   | 0   | 1   | 0   | 0   | 1   | 0   | 090000–097FFF                            |
| SA19   | 0   | 0   | 1   | 0   | 0   | 1   | 1   | 098000–09FFFF                            |
| SA20   | 0   | 0   | 1   | 0   | 1   | 0   | 0   | 0A0000–0A7FFF                            |
| SA21   | 0   | 0   | 1   | 0   | 1   | 0   | 1   | 0A8000–0AFFFF                            |
| SA22   | 0   | 0   | 1   | 0   | 1   | 1   | 0   | 0B0000–0B7FFF                            |
| SA23   | 0   | 0   | 1   | 0   | 1   | 1   | 1   | 0B8000–0BFFFF                            |
| SA24   | 0   | 0   | 1   | 1   | 0   | 0   | 0   | 0C0000–0C7FFF                            |
| SA25   | 0   | 0   | 1   | 1   | 0   | 0   | 1   | 0C8000–0CFFFF                            |
| SA26   | 0   | 0   | 1   | 1   | 0   | 1   | 0   | 0D0000–0D7FFF                            |
| SA27   | 0   | 0   | 1   | 1   | 0   | 1   | 1   | 0D8000–0DFFFF                            |
| SA28   | 0   | 0   | 1   | 1   | 1   | 0   | 0   | 0E0000–0E7FFF                            |
| SA29   | 0   | 0   | 1   | 1   | 1   | 0   | 1   | 0E8000–0EFFFF                            |
| SA30   | 0   | 0   | 1   | 1   | 1   | 1   | 0   | 0F0000–0F7FFF                            |
| SA31   | 0   | 0   | 1   | 1   | 1   | 1   | 1   | 0F8000–0FFFFF                            |
| SA32   | 0   | 1   | 0   | 0   | 0   | 0   | 0   | 100000–107FFF                            |
| SA33   | 0   | 1   | 0   | 0   | 0   | 0   | 1   | 108000–10FFFF                            |

Table 3. Sector Address Table for CE2# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA34   | 0   | 1   | 0   | 0   | 0   | 1   | 0   | 110000–117FFF                            |
| SA35   | 0   | 1   | 0   | 0   | 0   | 1   | 1   | 118000–11FFFF                            |
| SA36   | 0   | 1   | 0   | 0   | 1   | 0   | 0   | 120000–127FFF                            |
| SA37   | 0   | 1   | 0   | 0   | 1   | 0   | 1   | 128000–12FFFF                            |
| SA38   | 0   | 1   | 0   | 0   | 1   | 1   | 0   | 130000–137FFF                            |
| SA39   | 0   | 1   | 0   | 0   | 1   | 1   | 1   | 138000–13FFFF                            |
| SA40   | 0   | 1   | 0   | 1   | 0   | 0   | 0   | 140000–147FFF                            |
| SA41   | 0   | 1   | 0   | 1   | 0   | 0   | 1   | 148000–14FFFF                            |
| SA42   | 0   | 1   | 0   | 1   | 0   | 1   | 0   | 150000–157FFF                            |
| SA43   | 0   | 1   | 0   | 1   | 0   | 1   | 1   | 158000–15FFFF                            |
| SA44   | 0   | 1   | 0   | 1   | 1   | 0   | 0   | 160000–167FFF                            |
| SA45   | 0   | 1   | 0   | 1   | 1   | 0   | 1   | 168000–16FFFF                            |
| SA46   | 0   | 1   | 0   | 1   | 1   | 1   | 0   | 170000–177FFF                            |
| SA47   | 0   | 1   | 0   | 1   | 1   | 1   | 1   | 178000–17FFFF                            |
| SA48   | 0   | 1   | 1   | 0   | 0   | 0   | 0   | 180000–187FFF                            |
| SA49   | 0   | 1   | 1   | 0   | 0   | 0   | 1   | 188000–18FFFF                            |
| SA50   | 0   | 1   | 1   | 0   | 0   | 1   | 0   | 190000–197FFF                            |
| SA51   | 0   | 1   | 1   | 0   | 0   | 1   | 1   | 198000–19FFFF                            |
| SA52   | 0   | 1   | 1   | 0   | 1   | 0   | 0   | 1A0000–1A7FFF                            |
| SA53   | 0   | 1   | 1   | 0   | 1   | 0   | 1   | 1A8000–1AFFFF                            |
| SA54   | 0   | 1   | 1   | 0   | 1   | 1   | 0   | 1B0000–1B7FFF                            |
| SA55   | 0   | 1   | 1   | 0   | 1   | 1   | 1   | 1B8000–1BFFFF                            |
| SA56   | 0   | 1   | 1   | 1   | 0   | 0   | 0   | 1C0000–1C7FFF                            |
| SA57   | 0   | 1   | 1   | 1   | 0   | 0   | 1   | 1C8000–1CFFFF                            |
| SA58   | 0   | 1   | 1   | 1   | 0   | 1   | 0   | 1D0000–1D7FFF                            |
| SA59   | 0   | 1   | 1   | 1   | 0   | 1   | 1   | 1D8000–1DFFFF                            |
| SA60   | 0   | 1   | 1   | 1   | 1   | 0   | 0   | 1E0000–1E7FFF                            |
| SA61   | 0   | 1   | 1   | 1   | 1   | 0   | 1   | 1E8000–1EFFFF                            |
| SA62   | 0   | 1   | 1   | 1   | 1   | 1   | 0   | 1F0000–1F7FFF                            |
| SA63   | 0   | 1   | 1   | 1   | 1   | 1   | 1   | 1F8000–1FFFFF                            |
| SA64   | 1   | 0   | 0   | 0   | 0   | 0   | 0   | 200000–207FFF                            |
| SA65   | 1   | 0   | 0   | 0   | 0   | 0   | 1   | 208000–20FFFF                            |
| SA66   | 1   | 0   | 0   | 0   | 0   | 1   | 0   | 210000–217FFF                            |
| SA67   | 1   | 0   | 0   | 0   | 0   | 1   | 1   | 218000–21FFFF                            |
| SA68   | 1   | 0   | 0   | 0   | 1   | 0   | 0   | 220000–227FFF                            |

Table 3. Sector Address Table for CE2# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA69   | 1   | 0   | 0   | 0   | 1   | 0   | 1   | 228000–22FFFF                            |
| SA70   | 1   | 0   | 0   | 0   | 1   | 1   | 0   | 230000–237FFF                            |
| SA71   | 1   | 0   | 0   | 0   | 1   | 1   | 1   | 238000–23FFFF                            |
| SA72   | 1   | 0   | 0   | 1   | 0   | 0   | 0   | 240000–247FFF                            |
| SA73   | 1   | 0   | 0   | 1   | 0   | 0   | 1   | 248000–24FFFF                            |
| SA74   | 1   | 0   | 0   | 1   | 0   | 1   | 0   | 250000–257FFF                            |
| SA75   | 1   | 0   | 0   | 1   | 0   | 1   | 1   | 258000–25FFFF                            |
| SA76   | 1   | 0   | 0   | 1   | 1   | 0   | 0   | 260000–267FFF                            |
| SA77   | 1   | 0   | 0   | 1   | 1   | 0   | 1   | 268000–26FFFF                            |
| SA78   | 1   | 0   | 0   | 1   | 1   | 1   | 0   | 270000–277FFF                            |
| SA79   | 1   | 0   | 0   | 1   | 1   | 1   | 1   | 278000–27FFFF                            |
| SA80   | 1   | 0   | 1   | 0   | 0   | 0   | 0   | 280000–287FFF                            |
| SA81   | 1   | 0   | 1   | 0   | 0   | 0   | 1   | 288000–28FFFF                            |
| SA82   | 1   | 0   | 1   | 0   | 0   | 1   | 0   | 290000–297FFF                            |
| SA83   | 1   | 0   | 1   | 0   | 0   | 1   | 1   | 298000–29FFFF                            |
| SA84   | 1   | 0   | 1   | 0   | 1   | 0   | 0   | 2A0000–2A7FFF                            |
| SA85   | 1   | 0   | 1   | 0   | 1   | 0   | 1   | 2A8000–2AFFFF                            |
| SA86   | 1   | 0   | 1   | 0   | 1   | 1   | 0   | 2B0000–2B7FFF                            |
| SA87   | 1   | 0   | 1   | 0   | 1   | 1   | 1   | 2B8000–2BFFFF                            |
| SA88   | 1   | 0   | 1   | 1   | 0   | 0   | 0   | 2C0000–2C7FFF                            |
| SA89   | 1   | 0   | 1   | 1   | 0   | 0   | 1   | 2C8000–2CFFFF                            |
| SA90   | 1   | 0   | 1   | 1   | 0   | 1   | 0   | 2D0000–2D7FFF                            |
| SA91   | 1   | 0   | 1   | 1   | 0   | 1   | 1   | 2D8000–2DFFFF                            |
| SA92   | 1   | 0   | 1   | 1   | 1   | 0   | 0   | 2E0000–2E7FFF                            |
| SA93   | 1   | 0   | 1   | 1   | 1   | 0   | 1   | 2E8000–2EFFFF                            |
| SA94   | 1   | 0   | 1   | 1   | 1   | 1   | 0   | 2F0000–2F7FFF                            |
| SA95   | 1   | 0   | 1   | 1   | 1   | 1   | 1   | 2F8000–2FFFFF                            |
| SA96   | 1   | 1   | 0   | 0   | 0   | 0   | 0   | 300000–307FFF                            |
| SA97   | 1   | 1   | 0   | 0   | 0   | 0   | 1   | 308000–30FFFF                            |
| SA98   | 1   | 1   | 0   | 0   | 0   | 1   | 0   | 310000–317FFF                            |
| SA99   | 1   | 1   | 0   | 0   | 0   | 1   | 1   | 318000–31FFFF                            |
| SA100  | 1   | 1   | 0   | 0   | 1   | 0   | 0   | 320000–327FFF                            |
| SA101  | 1   | 1   | 0   | 0   | 1   | 0   | 1   | 328000–32FFFF                            |
| SA102  | 1   | 1   | 0   | 0   | 1   | 1   | 0   | 330000–337FFF                            |
| SA103  | 1   | 1   | 0   | 0   | 1   | 1   | 1   | 338000–33FFFF                            |

Table 3. Sector Address Table for CE2# (Continued)

| Sector | A21 | A20 | A19 | A18 | A17 | A16 | A15 | 16-bit Address Range<br>(in hexadecimal) |
|--------|-----|-----|-----|-----|-----|-----|-----|------------------------------------------|
| SA104  | 1   | 1   | 0   | 1   | 0   | 0   | 0   | 340000–347FFF                            |
| SA105  | 1   | 1   | 0   | 1   | 0   | 0   | 1   | 348000–34FFFF                            |
| SA106  | 1   | 1   | 0   | 1   | 0   | 1   | 0   | 350000–357FFF                            |
| SA107  | 1   | 1   | 0   | 1   | 0   | 1   | 1   | 358000–35FFFF                            |
| SA108  | 1   | 1   | 0   | 1   | 1   | 0   | 0   | 360000–367FFF                            |
| SA109  | 1   | 1   | 0   | 1   | 1   | 0   | 1   | 368000–36FFFF                            |
| SA110  | 1   | 1   | 0   | 1   | 1   | 1   | 0   | 370000–377FFF                            |
| SA111  | 1   | 1   | 0   | 1   | 1   | 1   | 1   | 378000–37FFFF                            |
| SA112  | 1   | 1   | 1   | 0   | 0   | 0   | 0   | 380000–387FFF                            |
| SA113  | 1   | 1   | 1   | 0   | 0   | 0   | 1   | 388000–38FFFF                            |
| SA114  | 1   | 1   | 1   | 0   | 0   | 1   | 0   | 390000–397FFF                            |
| SA115  | 1   | 1   | 1   | 0   | 0   | 1   | 1   | 398000–39FFFF                            |
| SA116  | 1   | 1   | 1   | 0   | 1   | 0   | 0   | 3A0000–3A7FFF                            |
| SA117  | 1   | 1   | 1   | 0   | 1   | 0   | 1   | 3A8000–3AFFFF                            |
| SA118  | 1   | 1   | 1   | 0   | 1   | 1   | 0   | 3B0000–3B7FFF                            |
| SA119  | 1   | 1   | 1   | 0   | 1   | 1   | 1   | 3B8000–3BFFFF                            |
| SA120  | 1   | 1   | 1   | 1   | 0   | 0   | 0   | 3C0000–3C7FFF                            |
| SA121  | 1   | 1   | 1   | 1   | 0   | 0   | 1   | 3C8000–3CFFFF                            |
| SA122  | 1   | 1   | 1   | 1   | 0   | 1   | 0   | 3D0000–3D7FFF                            |
| SA123  | 1   | 1   | 1   | 1   | 0   | 1   | 1   | 3D8000–3DFFFF                            |
| SA124  | 1   | 1   | 1   | 1   | 1   | 0   | 0   | 3E0000–3E7FFF                            |
| SA125  | 1   | 1   | 1   | 1   | 1   | 0   | 1   | 3E8000–3EFFFF                            |
| SA126  | 1   | 1   | 1   | 1   | 1   | 1   | 0   | 3F0000–3F7FFF                            |
| SA127  | 1   | 1   | 1   | 1   | 1   | 1   | 1   | 3F8000–3FFFFF                            |

**Note:** All sectors are 32 Kwords in size.

## Autoselect Mode

The autoselect mode provides manufacturer and device identification, and sector protection verification, through identifier codes output on DQ7–DQ0. This mode is primarily intended for programming equipment to automatically match a device to be programmed with its corresponding programming algorithm. However, the autoselect codes can also be accessed in-system through the command register.

When using programming equipment, the autoselect mode requires  $V_{ID}$  (8.5 V to 12.5 V) on address pin A9. Address pins A6, A1, and A0 must be as shown in

Table 4. In addition, when verifying sector protection, the sector address must appear on the appropriate highest order address bits (see Table 2 and Table 3). Table 4 shows the remaining address bits that are don't care. When all necessary bits have been set as required, the programming equipment may then read the corresponding identifier code on DQ7–DQ0.

To access the autoselect codes in-system, the host system can issue the autoselect command via the command register, as shown in Table 10. This method does not require  $V_{ID}$ . Refer to the Autoselect Command Sequence section for more information.

**Table 4. Am29LV642D Autoselect Codes, (High Voltage Method)**

| Description                    | CE# | OE# | WE# | A21 to A15 | A14 to A10 | A9       | A8 to A7 | A6 | A5 to A2 | A1 | A0 | DQ15 to DQ0                               |
|--------------------------------|-----|-----|-----|------------|------------|----------|----------|----|----------|----|----|-------------------------------------------|
| Manufacturer ID: AMD           | L   | L   | H   | X          | X          | $V_{ID}$ | X        | L  | X        | L  | L  | 0001h                                     |
| Device ID: Am29LV642D          | L   | L   | H   | X          | X          | $V_{ID}$ | X        | L  | X        | L  | H  | 22D7h                                     |
| Sector Protection Verification | L   | L   | H   | SA         | X          | $V_{ID}$ | X        | L  | X        | H  | L  | XX01h (protected),<br>XX00h (unprotected) |

**Legend:** L = Logic Low =  $V_{IL}$ , H = Logic High =  $V_{IH}$ , SA = Sector Address, X = Don't care.

### Notes:

1. CE# can be replaced with CE2# when referring to the second die in the package.
2. The device ID's used for the Am29LV642 are the same as the Am29LV640, because the Am29LV642 uses two Am29LV640 dice and appears to the system as two Am29LV640 devices.

## Sector Group Protection and Unprotection

The hardware sector group protection feature disables both program and erase operations in any sector group. In this device, a sector group consists of four adjacent sectors that are protected or unprotected at the same time (see Table 5). The hardware sector group unprotection feature re-enables both program and erase operations in previously protected sector groups. Sector group protection/unprotection can be implemented via two methods.

The primary method requires  $V_{ID}$  on the RESET# pin only, and can be implemented either in-system or via programming equipment. Figure 2 shows the algorithms and Figure 22 shows the timing diagram. This method uses standard microprocessor bus cycle timing. For sector group unprotect, all unprotected sector groups must first be protected prior to the first sector group unprotect write cycle.

Some earlier 3.0 volt-only AMD flash devices used a sector protection/unprotection method intended only for programming equipment, and required  $V_{ID}$  on address pin A9 and OE#. If this earlier method is required for the intended application, contact AMD for further details.

The device is shipped with all sector groups unprotected. AMD offers the option of programming and protecting sector groups at its factory prior to shipping the device through AMD's ExpressFlash™ Service. Contact an AMD representative for details.

It is possible to determine whether a sector group is protected or unprotected. See the Autoselect Mode section for details.

**Table 5. Sector Group Protection/Unprotection Address Table**

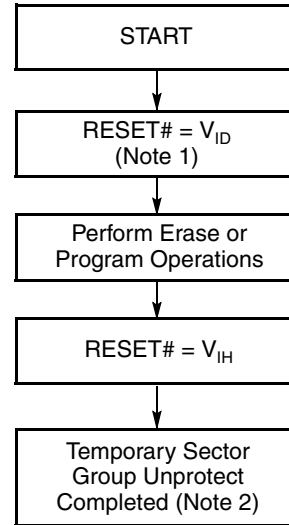
| Sector Group | A22–A18 |
|--------------|---------|
| SA0–SA3      | 00000   |
| SA4–SA7      | 00001   |
| SA8–SA11     | 00010   |
| SA12–SA15    | 00011   |
| SA16–SA19    | 00100   |
| SA20–SA23    | 00101   |
| SA24–SA27    | 00110   |
| SA28–SA31    | 00111   |
| SA32–SA35    | 01000   |
| SA36–SA39    | 01001   |
| SA40–SA43    | 01010   |
| SA44–SA47    | 01011   |
| SA48–SA51    | 01100   |
| SA52–SA55    | 01101   |
| SA56–SA59    | 01110   |
| SA60–SA63    | 01111   |
| SA64–SA67    | 10000   |
| SA68–SA71    | 10001   |
| SA72–SA75    | 10010   |
| SA76–SA79    | 10011   |
| SA80–SA83    | 10100   |
| SA84–SA87    | 10101   |
| SA88–SA91    | 10110   |
| SA92–SA95    | 10111   |
| SA96–SA99    | 11000   |
| SA100–SA103  | 11001   |
| SA104–SA107  | 11010   |
| SA108–SA111  | 11011   |
| SA112–SA115  | 11100   |
| SA116–SA119  | 11101   |
| SA120–SA123  | 11110   |
| SA124–SA127  | 11111   |

**Note:** All sector groups are 128 Kwords in size.

## Temporary Sector Group Unprotect

**(Note:** In this device, a sector group consists of four adjacent sectors that are protected or unprotected at the same time (see Table 5)).

This feature allows temporary unprotection of previously protected sector groups to change data in-system. The Sector Group Unprotect mode is activated by setting the RESET# pin to  $V_{ID}$  (8.5 V – 12.5 V). During this mode, formerly protected sector groups can be programmed or erased by selecting the sector group addresses. Once  $V_{ID}$  is removed from the RESET# pin, all the previously protected sector groups are protected again. Figure 1 shows the algorithm, and Figure 21 shows the timing diagrams, for this feature.



**Notes:**

1. All protected sector groups unprotected.
2. All previously protected sector groups are protected once again.

**Figure 1. Temporary Sector Group Unprotect Operation**

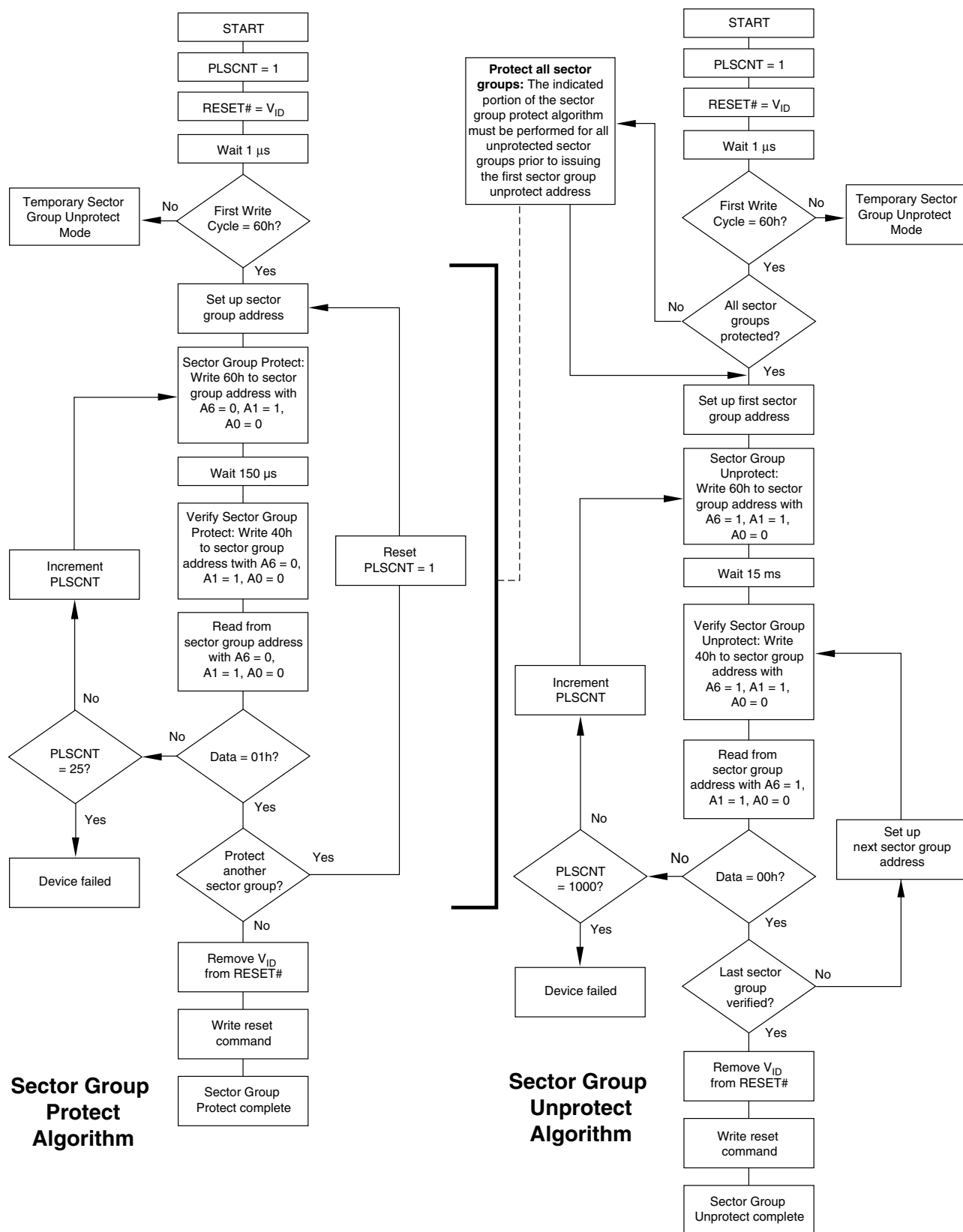


Figure 2. In-System Sector Group Protect/Unprotect Algorithms



## Hardware Data Protection

The command sequence requirement of unlock cycles for programming or erasing provides data protection against inadvertent writes (refer to Table 10 for command definitions). In addition, the following hardware data protection measures prevent accidental erasure or programming, which might otherwise be caused by spurious system level signals during  $V_{CC}$  power-up and power-down transitions, or from system noise.

### Low $V_{CC}$ Write Inhibit

When  $V_{CC}$  is less than  $V_{LKO}$ , the device does not accept any write cycles. This protects data during  $V_{CC}$  power-up and power-down. The command register and all internal program/erase circuits are disabled, and the device resets to the read mode. Subsequent writes are ignored until  $V_{CC}$  is greater than  $V_{LKO}$ . The system must provide the proper signals to the control

pins to prevent unintentional writes when  $V_{CC}$  is greater than  $V_{LKO}$ .

### Write Pulse “Glitch” Protection

Noise pulses of less than 5 ns (typical) on OE#, CE#, CE2#, or WE# do not initiate a write cycle.

### Logical Inhibit

Write cycles are inhibited by holding any one of OE# =  $V_{IL}$ , CE# =  $V_{IH}$ , CE2# =  $V_{IH}$  or WE# =  $V_{IH}$ . To initiate a write cycle, CE# (or CE2#), and WE# must be a logical zero while OE# is a logical one.

### Power-Up Write Inhibit

If WE# = CE# = CE2# =  $V_{IL}$  and OE# =  $V_{IH}$  during power up, the device does not accept commands on the rising edge of WE#. The internal state machine is automatically reset to the read mode on power-up.

## COMMON FLASH MEMORY INTERFACE (CFI)

The Common Flash Interface (CFI) specification outlines device and host system software interrogation handshake, which allows specific vendor-specified software algorithms to be used for entire families of devices. Software support can then be device-independent, JEDEC ID-independent, and forward- and backward-compatible for the specified flash device families. Flash vendors can standardize their existing interfaces for long-term compatibility.

The Am29LV642 is a two die solution which appears as two 64 Mbit Am29LV640 devices in the system. This allows the same CFI information to be used because the system “sees” two 64 Mbit devices, not a single 128 Mbit device.

This device enters the CFI Query mode when the system writes the CFI Query command, 98h, to address

55h anytime the device is ready to read array data. The system can read CFI information at the addresses given in Tables 6–9. To terminate reading CFI data, the system must write the reset command.

The system can also write the CFI query command when the device is in the autoselect mode. The device enters the CFI query mode, and the system can read CFI data at the addresses given in Tables 6–9. The system must write the reset command to return the device to the autoselect mode.

For further information, please refer to the CFI Specification and CFI Publication 100, available via the World Wide Web at <http://www.amd.com/products/nvd/overview/cfi.html>. Alternatively, contact an AMD representative for copies of these documents.

**Table 6. CFI Query Identification String**

| Addresses (x16)   | Data                    | Description                                                  |
|-------------------|-------------------------|--------------------------------------------------------------|
| 10h<br>11h<br>12h | 0051h<br>0052h<br>0059h | Query Unique ASCII string “QRY”                              |
| 13h<br>14h        | 0002h<br>0000h          | Primary OEM Command Set                                      |
| 15h<br>16h        | 0040h<br>0000h          | Address for Primary Extended Table                           |
| 17h<br>18h        | 0000h<br>0000h          | Alternate OEM Command Set (00h = none exists)                |
| 19h<br>1Ah        | 0000h<br>0000h          | Address for Alternate OEM Extended Table (00h = none exists) |

Table 7. System Interface String

| Addresses (x16) | Data  | Description                                                                         |
|-----------------|-------|-------------------------------------------------------------------------------------|
| 1Bh             | 0030h | V <sub>CC</sub> Min. (write/erase)<br>D7–D4: volt, D3–D0: 100 millivolt             |
| 1Ch             | 0036h | V <sub>CC</sub> Max. (write/erase)<br>D7–D4: volt, D3–D0: 100 millivolt             |
| 1Dh             | 0000h | V <sub>PP</sub> Min. voltage (00h = no V <sub>PP</sub> pin present)                 |
| 1Eh             | 0000h | V <sub>PP</sub> Max. voltage (00h = no V <sub>PP</sub> pin present)                 |
| 1Fh             | 0004h | Typical timeout per single word write 2 <sup>N</sup> μs                             |
| 20h             | 0000h | Typical timeout for Min. size buffer write 2 <sup>N</sup> μs (00h = not supported)  |
| 21h             | 000Ah | Typical timeout per individual block erase 2 <sup>N</sup> ms                        |
| 22h             | 0000h | Typical timeout for full chip erase 2 <sup>N</sup> ms (00h = not supported)         |
| 23h             | 0005h | Max. timeout for word write 2 <sup>N</sup> times typical                            |
| 24h             | 0000h | Max. timeout for buffer write 2 <sup>N</sup> times typical                          |
| 25h             | 0004h | Max. timeout per individual block erase 2 <sup>N</sup> times typical                |
| 26h             | 0000h | Max. timeout for full chip erase 2 <sup>N</sup> times typical (00h = not supported) |

Table 8. Device Geometry Definition

| Addresses (x16)          | Data                             | Description                                                                                 |
|--------------------------|----------------------------------|---------------------------------------------------------------------------------------------|
| 27h                      | 0017h                            | Device Size = 2 <sup>N</sup> word                                                           |
| 28h<br>29h               | 0000h<br>0000h                   | Flash Device Interface description (refer to CFI publication 100)                           |
| 2Ah<br>2Bh               | 0000h<br>0000h                   | Max. number of words in multi-word write = 2 <sup>N</sup><br>(00h = not supported)          |
| 2Ch                      | 0001h                            | Number of Erase Block Regions within device                                                 |
| 2Dh<br>2Eh<br>2Fh<br>30h | 007Fh<br>0000h<br>0000h<br>0001h | Erase Block Region 1 Information<br>(refer to the CFI specification or CFI publication 100) |
| 31h<br>32h<br>33h<br>34h | 0000h<br>0000h<br>0000h<br>0000h | Erase Block Region 2 Information (refer to CFI publication 100)                             |
| 35h<br>36h<br>37h<br>38h | 0000h<br>0000h<br>0000h<br>0000h | Erase Block Region 3 Information (refer to CFI publication 100)                             |
| 39h<br>3Ah<br>3Bh<br>3Ch | 0000h<br>0000h<br>0000h<br>0000h | Erase Block Region 4 Information (refer to CFI publication 100)                             |

Table 9. Primary Vendor-Specific Extended Query

| Addresses (x16)   | Data                    | Description                                                                                                 |
|-------------------|-------------------------|-------------------------------------------------------------------------------------------------------------|
| 40h<br>41h<br>42h | 0050h<br>0052h<br>0049h | Query-unique ASCII string "PRI"                                                                             |
| 43h               | 0031h                   | Major version number, ASCII                                                                                 |
| 44h               | 0031h                   | Minor version number, ASCII                                                                                 |
| 45h               | 0001h                   | Address Sensitive Unlock (Bits 1-0)<br>0 = Required, 1 = Not Required<br>Silicon Revision Number (Bits 7-2) |
| 46h               | 0002h                   | Erase Suspend<br>0 = Not Supported, 1 = To Read Only, 2 = To Read & Write                                   |
| 47h               | 0004h                   | Sector Protect<br>0 = Not Supported, X = Number of sectors in per group                                     |
| 48h               | 0001h                   | Sector Temporary Unprotect<br>00 = Not Supported, 01 = Supported                                            |
| 49h               | 0004h                   | Sector Protect/Unprotect scheme<br>04 = 29LV800 mode                                                        |
| 4Ah               | 0000h                   | Simultaneous Operation<br>00 = Not Supported, X = Number of Sectors in Bank                                 |
| 4Bh               | 0000h                   | Burst Mode Type<br>00 = Not Supported, 01 = Supported                                                       |
| 4Ch               | 0000h                   | Page Mode Type<br>00 = Not Supported                                                                        |
| 4Dh               | 00B5h                   | ACC (Acceleration) Supply Minimum<br>00h = Not Supported, D7-D4: Volt, D3-D0: 100 mV                        |
| 4Eh               | 00C5h                   | ACC (Acceleration) Supply Maximum<br>00h = Not Supported, D7-D4: Volt, D3-D0: 100 mV                        |
| 4Fh               | 0000h                   | Top/Bottom Boot Sector Flag<br>02h = Bottom Boot Device, 03h = Top Boot Device                              |

## COMMAND DEFINITIONS

Writing specific address and data commands or sequences into the command register initiates device operations. Table 10 defines the valid register command sequences. Writing **incorrect address and data values** or writing them in the **improper sequence** resets the device to reading array data.

All addresses are latched on the falling edge of WE# or CE# (or CE2#), whichever happens later. All data is latched on the rising edge of WE# or CE# (or CE2#), whichever happens first. Refer to the AC Characteristics section for timing diagrams.

### Reading Array Data

The device is automatically set to reading array data after device power-up. No commands are required to retrieve data. The device is ready to read array data

after completing an Embedded Program or Embedded Erase algorithm.

After the device accepts an Erase Suspend command, the device enters the erase-suspend-read mode, after which the system can read data from any non-erase-suspended sector. After completing a programming operation in the Erase Suspend mode, the system may once again read array data with the same exception. See the Erase Suspend/Erase Resume Commands section for more information.

The system *must* issue the reset command to return the device to the read (or erase-suspend-read) mode if DQ5 goes high during an active program or erase operation, or if the device is in the autoselect mode. See the next section, Reset Command, for more information.

See also “VersatileI/O™ (V<sub>IO</sub>) Control” in the Device Bus Operations section for more information. The Read-Only Operations table provides the read parameters, and Figure 13 shows the timing diagram.

## Reset Command

Writing the reset command resets the device to the read or erase-suspend-read mode. Address bits are don't cares for this command.

The reset command may be written between the sequence cycles in an erase command sequence before erasing begins. This resets the device to the read mode. Once erasure begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in a program command sequence before programming begins. This resets the device to the read mode. If the program command sequence is written while the device is in the Erase Suspend mode, writing the reset command returns the device to the erase-suspend-read mode. Once programming begins, however, the device ignores reset commands until the operation is complete.

The reset command may be written between the sequence cycles in an autoselect command sequence. Once in the autoselect mode, the reset command must be written to return to the read mode. If the device entered the autoselect mode while in the Erase Suspend mode, writing the reset command returns the device to the erase-suspend-read mode.

If DQ5 goes high during a program or erase operation, writing the reset command returns the device to the read mode (or erase-suspend-read mode if the device was in Erase Suspend).

## Autoselect Command Sequence

The autoselect command sequence allows the host system to access the manufacturer and device codes, and determine whether or not a sector is protected. Table 10 shows the address and data requirements. This method is an alternative to that shown in Table 4, which is intended for PROM programmers and requires V<sub>ID</sub> on address pin A9. The autoselect command sequence may be written to an address that is either in the read or erase-suspend-read mode. The autoselect command may not be written while the device is actively programming or erasing.

The autoselect command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle that contains the autoselect command. The device then enters the autoselect mode. The system may read at any address any number of times without initiating another autoselect command sequence:

- A read cycle at address XX00h returns the manufacturer code.
- A read cycle at address XX01h returns the device code.
- A read cycle to an address containing a sector group address (SA), and the address 02h on A7–A0 returns 01h if the sector group is protected, or 00h if it is unprotected. (Refer to Table 5 for valid sector addresses).

The system must write the reset command to return to the read mode (or erase-suspend-read mode if the device was previously in Erase Suspend).

## Word Program Command Sequence

Programming is a four-bus-cycle operation. The program command sequence is initiated by writing two unlock write cycles, followed by the program set-up command. The program address and data are written next, which in turn initiate the Embedded Program algorithm. The system is *not* required to provide further controls or timings. The device automatically provides internally generated program pulses and verifies the programmed cell margin. Table 10 shows the address and data requirements for the word program command sequence.

When the Embedded Program algorithm is complete, the device then returns to the read mode and addresses are no longer latched. The system can determine the status of the program operation by using DQ7, DQ6, or RY/BY#. Refer to the Write Operation Status section for information on these status bits.

Any commands written to the device during the Embedded Program Algorithm are ignored. Note that a **hardware reset** immediately terminates the program operation. The program command sequence should be reinitiated once the device has returned to the read mode, to ensure data integrity.

Programming is allowed in any sequence and across sector boundaries. **A bit cannot be programmed from “0” back to a “1.”** Attempting to do so may cause the device to set DQ5 = 1, or cause the DQ7 and DQ6 status bits to indicate the operation was successful. However, a succeeding read will show that the data is still “0.” Only erase operations can convert a “0” to a “1.”

## Unlock Bypass Command Sequence

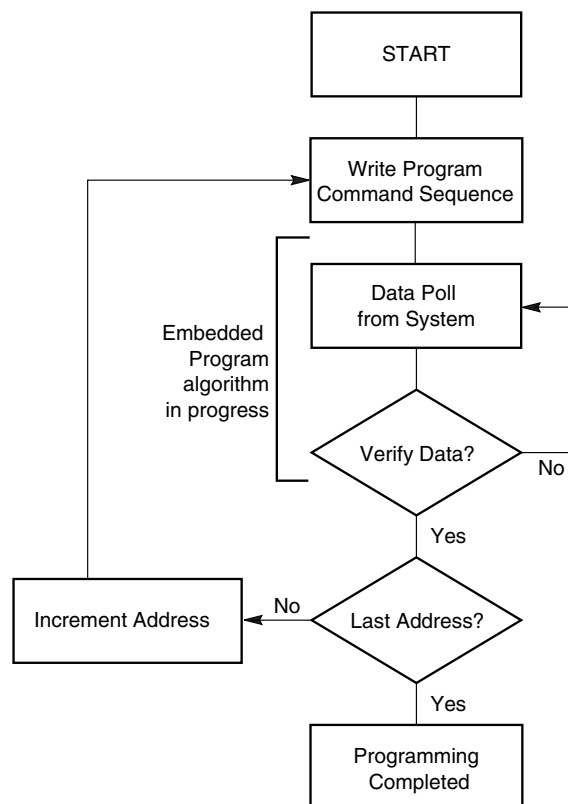
The unlock bypass feature allows the system to program words to the device faster than using the standard program command sequence. The unlock bypass command sequence is initiated by first writing two unlock cycles. This is followed by a third write cycle containing the unlock bypass command, 20h. The device then enters the unlock bypass mode. A two-cycle unlock bypass program command sequence is all that is

required to program in this mode. The first cycle in this sequence contains the unlock bypass program command, A0h; the second cycle contains the program address and data. Additional data is programmed in the same manner. This mode dispenses with the initial two unlock cycles required in the standard program command sequence, resulting in faster total programming time. Table 10 shows the requirements for the command sequence.

During the unlock bypass mode, only the Unlock Bypass Program and Unlock Bypass Reset commands are valid. To exit the unlock bypass mode, the system must issue the two-cycle unlock bypass reset command sequence. The first cycle must contain the data 90h. The second cycle must contain the data 00h. The device then returns to the read mode.

The device offers accelerated program operations through the ACC pin. When the system asserts  $V_{HH}$  on the ACC pin, the device automatically enters the Unlock Bypass mode. The system may then write the two-cycle Unlock Bypass program command sequence. The device uses the higher voltage on the ACC pin to accelerate the operation. *Note that the ACC pin must not be at  $V_{HH}$  for operations other than accelerated programming, or device damage may result.*

Figure 3 illustrates the algorithm for the program operation. Refer to the Erase and Program Operations table in the AC Characteristics section for parameters, and Figure 15 for timing diagrams.



**Note:** See Table 10 for program command sequence.

**Figure 3. Program Operation**

## Chip Erase Command Sequence

Chip erase is a six bus cycle operation. The chip erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock write cycles are then followed by the chip erase command, which in turn invokes the Embedded Erase algorithm. The device does *not* require the system to preprogram prior to erase. The Embedded Erase algorithm automatically preprograms and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations. Table 10 shows the address and data requirements for the chip erase command sequence.

When the Embedded Erase algorithm is complete, the device returns to the read mode and addresses are no longer latched. The system can determine the status of the erase operation by using DQ7, DQ6, DQ2, or RY/BY#. Refer to the Write Operation Status section for information on these status bits.

Any commands written during the chip erase operation are ignored. However, note that a **hardware reset** immediately terminates the erase operation. If that occurs, the chip erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 17 section for timing diagrams.

### Sector Erase Command Sequence

Sector erase is a six bus cycle operation. The sector erase command sequence is initiated by writing two unlock cycles, followed by a set-up command. Two additional unlock cycles are written, and are then followed by the address of the sector to be erased, and the sector erase command. Table 10 shows the address and data requirements for the sector erase command sequence.

The device does *not* require the system to preprogram prior to erase. The Embedded Erase algorithm automatically programs and verifies the entire memory for an all zero data pattern prior to electrical erase. The system is not required to provide any controls or timings during these operations.

After the command sequence is written, a sector erase time-out of 50  $\mu$ s occurs. During the time-out period, additional sector addresses and sector erase commands may be written. Loading the sector erase buffer may be done in any sequence, and the number of sectors may be from one sector to all sectors. The time between these additional cycles must be less than 50  $\mu$ s, otherwise erasure may begin. Any sector erase address and command following the exceeded time-out may or may not be accepted. It is recommended that processor interrupts be disabled during this time to ensure all commands are accepted. The interrupts can be re-enabled after the last Sector Erase command is written. **Any command other than Sector Erase or Erase Suspend during the time-out period resets the device to the read mode.** The system must rewrite the command sequence and any additional addresses and commands.

The system can monitor DQ3 to determine if the sector erase timer has timed out (See the section on DQ3: Sector Erase Timer.). The time-out begins from the rising edge of the final WE# pulse in the command sequence.

When the Embedded Erase algorithm is complete, the device returns to reading array data and addresses are no longer latched. The system can determine the status of the erase operation by reading DQ7, DQ6, DQ2, or RY/BY# in the erasing sector. Refer to the Write Operation Status section for information on these status bits.

Once the sector erase operation has begun, only the Erase Suspend command is valid. All other commands are ignored. However, note that a **hardware reset** immediately terminates the erase operation. If that occurs, the sector erase command sequence should be reinitiated once the device has returned to reading array data, to ensure data integrity.

Figure 4 illustrates the algorithm for the erase operation. Refer to the Erase and Program Operations tables in the AC Characteristics section for parameters, and Figure 17 section for timing diagrams.

### Erase Suspend/Erase Resume Commands

The Erase Suspend command, B0h, allows the system to interrupt a sector erase operation and then read data from, or program data to, any sector not selected for erasure. This command is valid only during the sector erase operation, including the 50  $\mu$ s time-out period during the sector erase command sequence. The Erase Suspend command is ignored if written during the chip erase operation or Embedded Program algorithm.

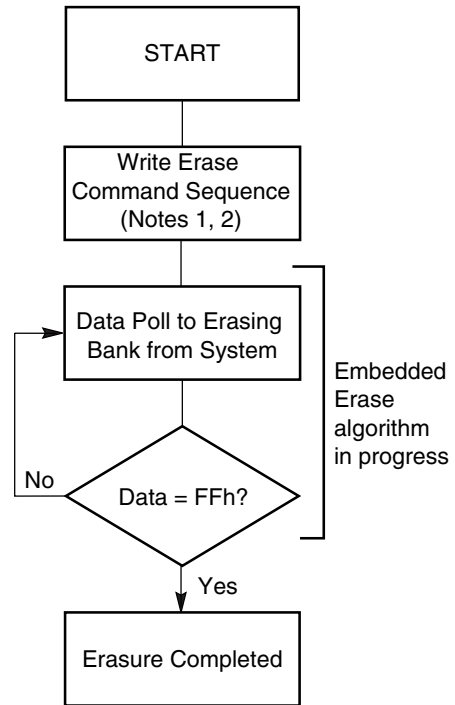
When the Erase Suspend command is written during the sector erase operation, the device requires a maximum of 20  $\mu$ s to suspend the erase operation. However, when the Erase Suspend command is written during the sector erase time-out, the device immediately terminates the time-out period and suspends the erase operation.

After the erase operation has been suspended, the device enters the erase-suspend-read mode. The system can read data from or program data to any sector not selected for erasure. (The device “erase suspends” all sectors selected for erasure.) Reading at any address within erase-suspended sectors produces status information on DQ7–DQ0. The system can use DQ7, or DQ6 and DQ2 together, to determine if a sector is actively erasing or is erase-suspended. Refer to the Write Operation Status section for information on these status bits.

After an erase-suspended program operation is complete, the device returns to the erase-suspend-read mode. The system can determine the status of the program operation using the DQ7 or DQ6 status bits, just as in the standard word program operation. Refer to the Write Operation Status section for more information.

In the erase-suspend-read mode, the system can also issue the autoselect command sequence. Refer to the Autoselect Mode and Autoselect Command Sequence sections for details.

To resume the sector erase operation, the system must write the Erase Resume command. The address of the erase-suspended sector is required when writing this command. Further writes of the Resume command are ignored. Another Erase Suspend command can be written after the chip has resumed erasing.



**Notes:**

1. See Table 10 for erase command sequence.
2. See the section on DQ3 for information on the sector erase timer.

**Figure 4. Erase Operation**



## Command Definitions

Table 10. Am29LV642D Command Definitions

| Command Sequence (Note 1)       |                                      | Cycles | Bus Cycles (Notes 2–5) |      |        |      |       |      |         |           |       |      |       |      |
|---------------------------------|--------------------------------------|--------|------------------------|------|--------|------|-------|------|---------|-----------|-------|------|-------|------|
|                                 |                                      |        | First                  |      | Second |      | Third |      | Fourth  |           | Fifth |      | Sixth |      |
|                                 |                                      |        | Addr                   | Data | Addr   | Data | Addr  | Data | Addr    | Data      | Addr  | Data | Addr  | Data |
| Read (Note 6)                   |                                      | 1      | RA                     | RD   |        |      |       |      |         |           |       |      |       |      |
| Reset (Note 7)                  |                                      | 1      | XXX                    | F0   |        |      |       |      |         |           |       |      |       |      |
| Autoselect (Note 8)             | Manufacturer ID                      | 4      | 555                    | AA   | 2AA    | 55   | 555   | 90   | X00     | 0001      |       |      |       |      |
|                                 | Device ID                            | 4      | 555                    | AA   | 2AA    | 55   | 555   | 90   | X01     | 22D7      |       |      |       |      |
|                                 | Sector Group Protect Verify (Note 9) | 4      | 555                    | AA   | 2AA    | 55   | 555   | 90   | (SA)X02 | XX00/XX01 |       |      |       |      |
| Enter SecSi Sector Region       |                                      | 3      | 555                    | AA   | 2AA    | 55   | 555   | 88   |         |           |       |      |       |      |
| Exit SecSi Sector Region        |                                      | 4      | 555                    | AA   | 2AA    | 55   | 555   | 90   | XXX     | 00        |       |      |       |      |
| Program                         |                                      | 4      | 555                    | AA   | 2AA    | 55   | 555   | A0   | PA      | PD        |       |      |       |      |
| Unlock Bypass                   |                                      | 3      | 555                    | AA   | 2AA    | 55   | 555   | 20   |         |           |       |      |       |      |
| Unlock Bypass Program (Note 10) |                                      | 2      | XXX                    | A0   | PA     | PD   |       |      |         |           |       |      |       |      |
| Unlock Bypass Reset (Note 11)   |                                      | 2      | XXX                    | 90   | XXX    | 00   |       |      |         |           |       |      |       |      |
| Chip Erase                      |                                      | 6      | 555                    | AA   | 2AA    | 55   | 555   | 80   | 555     | AA        | 2AA   | 55   | 555   | 10   |
| Sector Erase                    |                                      | 6      | 555                    | AA   | 2AA    | 55   | 555   | 80   | 555     | AA        | 2AA   | 55   | SA    | 30   |
| Erase Suspend (Note 12)         |                                      | 1      | BA                     | B0   |        |      |       |      |         |           |       |      |       |      |
| Erase Resume (Note 13)          |                                      | 1      | BA                     | 30   |        |      |       |      |         |           |       |      |       |      |
| CFI Query (Note 14)             |                                      | 1      | 55                     | 98   |        |      |       |      |         |           |       |      |       |      |

**Legend:**

X = Don't care

RA = Address of the memory location to be read.

RD = Data read from location RA during read operation.

PA = Address of the memory location to be programmed. Addresses latch on the falling edge of the WE# or CE# (or CE2#) pulse, whichever happens later.

PD = Data to be programmed at location PA. Data latches on the rising edge of WE# or CE# (or CE2#) pulse, whichever happens first.

SA = Address of the sector to be verified (in autoselect mode) or erased. Address bits A21–A15 uniquely select any sector.

**Notes:**

- See Table 1 for description of bus operations.
- All values are in hexadecimal.
- Except for the read cycle and the fourth cycle of the autoselect command sequence, all bus cycles are write cycles.
- Data bits DQ15–DQ8 are don't care in command sequences, except for RD and PD.
- Unless otherwise noted, address bits A21–A15 are don't cares.
- No unlock or command cycles required when device is in read mode.
- The Reset command is required to return to the read mode (or to the erase-suspend-read mode if previously in Erase Suspend) when the device is in the autoselect mode, or if DQ5 goes high (while the device is providing status information).
- The fourth cycle of the autoselect command sequence is a read cycle. See the Autoselect Command Sequence section for more information.
- The data is 00h for an unprotected sector group and 01h for a protected sector group.
- The Unlock Bypass command is required prior to the Unlock Bypass Program command.
- The Unlock Bypass Reset command is required to return to the read mode when the device is in the unlock bypass mode.
- The system may read and program in non-erasing sectors, or enter the autoselect mode, when in the Erase Suspend mode. The Erase Suspend command is valid only during a sector erase operation.
- The Erase Resume command is valid only during the Erase Suspend mode.
- Command is valid when device is ready to read array data or when device is in autoselect mode.



## WRITE OPERATION STATUS

The device provides several bits to determine the status of a program or erase operation: DQ2, DQ3, DQ5, DQ6, and DQ7. Table 11 and the following subsections describe the function of these bits. DQ7 and DQ6 each offer a method for determining whether a program or erase operation is complete or in progress. The device also provides a hardware-based output signal, RY/BY#, to determine whether an Embedded Program or Erase operation is in progress or has been completed.

### DQ7: Data# Polling

The Data# Polling bit, DQ7, indicates to the host system whether an Embedded Program or Erase algorithm is in progress or completed, or whether the device is in Erase Suspend. Data# Polling is valid after the rising edge of the final WE# pulse in the command sequence.

During the Embedded Program algorithm, the device outputs on DQ7 the complement of the datum programmed to DQ7. This DQ7 status also applies to programming during Erase Suspend. When the Embedded Program algorithm is complete, the device outputs the datum programmed to DQ7. The system must provide the program address to read valid status information on DQ7. If a program address falls within a protected sector, Data# Polling on DQ7 is active for approximately 1  $\mu$ s, then the device returns to the read mode.

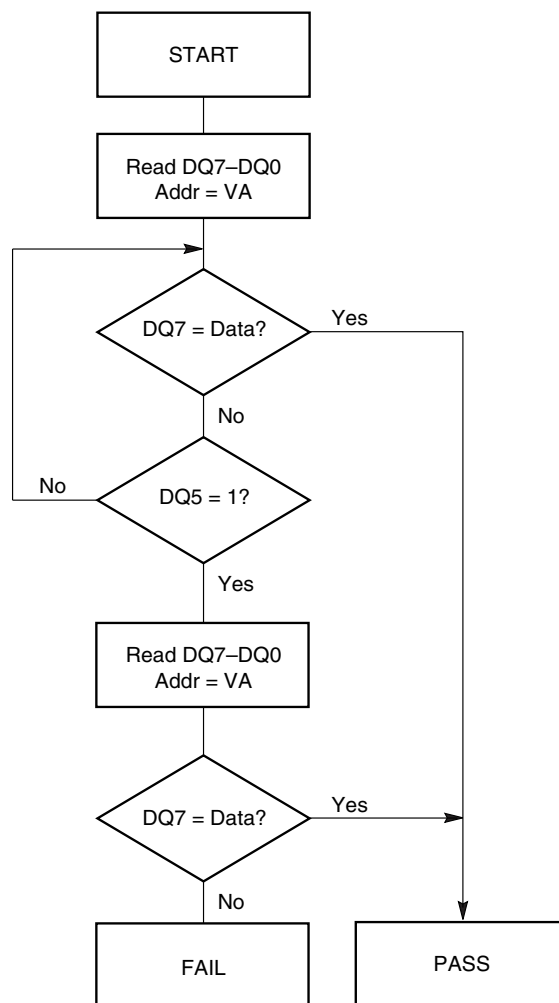
During the Embedded Erase algorithm, Data# Polling produces a “0” on DQ7. When the Embedded Erase algorithm is complete, or if the device enters the Erase Suspend mode, Data# Polling produces a “1” on DQ7. The system must provide an address within any of the sectors selected for erasure to read valid status information on DQ7.

After an erase command sequence is written, if all sectors selected for erasing are protected, Data# Polling on DQ7 is active for approximately 100  $\mu$ s, then the device returns to the read mode. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected. However, if the system reads DQ7 at an address within a protected sector, the status may not be valid.

Just prior to the completion of an Embedded Program or Erase operation, DQ7 may change asynchronously with DQ0–DQ6 while Output Enable (OE#) is asserted low. That is, the device may change from providing status information to valid data on DQ7. Depending on when the system samples the DQ7 output, it may read the status or valid data. Even if the device has completed the program or erase operation and DQ7 has

valid data, the data outputs on DQ0–DQ6 may be still invalid. Valid data on DQ0–DQ7 will appear on successive read cycles.

Table 11 shows the outputs for Data# Polling on DQ7. Figure 5 shows the Data# Polling algorithm. Figure 18 in the AC Characteristics section shows the Data# Polling timing diagram.



#### Notes:

1. VA = Valid address for programming. During a sector erase operation, a valid address is any sector address within the sector being erased. During chip erase, a valid address is any non-protected sector address.
2. DQ7 should be rechecked even if DQ5 = “1” because DQ7 may change simultaneously with DQ5.

**Figure 5. Data# Polling Algorithm**

## RY/BY#: Ready/Busy#

The RY/BY# is a dedicated, open-drain output pin which indicates whether an Embedded Algorithm is in progress or complete. The RY/BY# status is valid after the rising edge of the final WE# pulse in the command sequence. Since RY/BY# is an open-drain output, several RY/BY# pins can be tied together in parallel with a pull-up resistor to  $V_{CC}$ .

If the output is low (Busy), the device is actively erasing or programming. (This includes programming in the Erase Suspend mode.) If the output is high (Ready), the device is in the read mode, the standby mode, or the device is in the erase-suspend-read mode.

Table 11 shows the outputs for RY/BY#.

## DQ6: Toggle Bit I

Toggle Bit I on DQ6 indicates whether an Embedded Program or Erase algorithm is in progress or complete, or whether the device has entered the Erase Suspend mode. Toggle Bit I may be read at any address, and is valid after the rising edge of the final WE# pulse in the command sequence (prior to the program or erase operation), and during the sector erase time-out.

During an Embedded Program or Erase algorithm operation, successive read cycles to any address cause DQ6 to toggle. The system may use either OE# or CE# (or CE2#) to control the read cycles. When the operation is complete, DQ6 stops toggling.

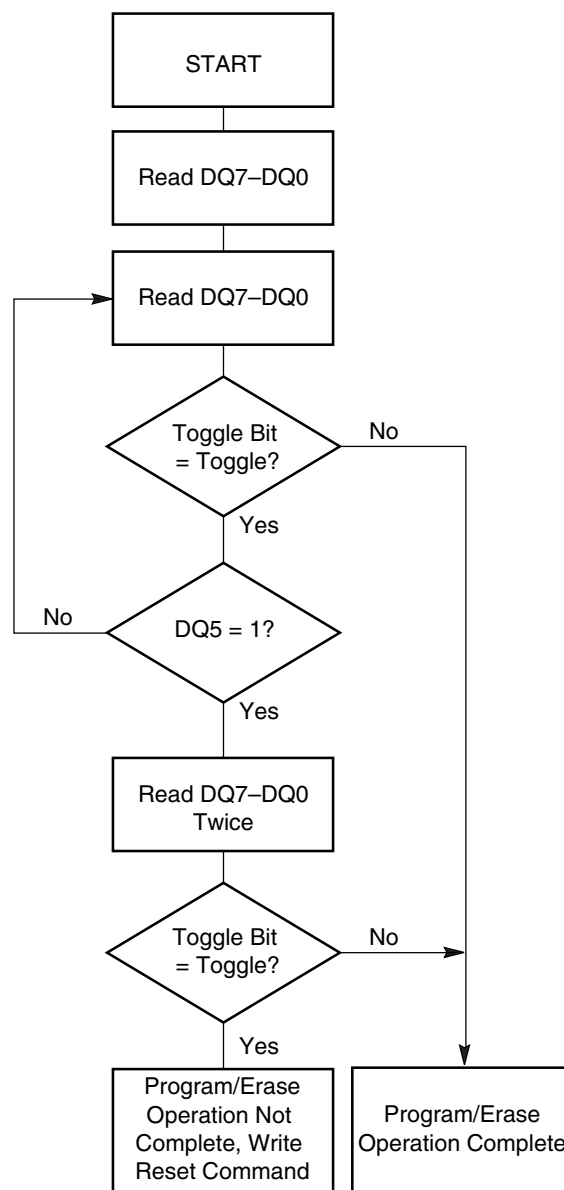
After an erase command sequence is written, if all sectors selected for erasing are protected, DQ6 toggles for approximately 100  $\mu$ s, then returns to reading array data. If not all selected sectors are protected, the Embedded Erase algorithm erases the unprotected sectors, and ignores the selected sectors that are protected.

The system can use DQ6 and DQ2 together to determine whether a sector is actively erasing or is erase-suspended. When the device is actively erasing (that is, the Embedded Erase algorithm is in progress), DQ6 toggles. When the device enters the Erase Suspend mode, DQ6 stops toggling. However, the system must also use DQ2 to determine which sectors are erasing or erase-suspended. Alternatively, the system can use DQ7 (see the subsection on DQ7: Data# Polling).

If a program address falls within a protected sector, DQ6 toggles for approximately 1  $\mu$ s after the program command sequence is written, then returns to reading array data.

DQ6 also toggles during the erase-suspend-program mode, and stops toggling once the Embedded Program algorithm is complete.

Table 11 shows the outputs for Toggle Bit I on DQ6. Figure 6 shows the toggle bit algorithm. Figure 19 in the “AC Characteristics” section shows the toggle bit timing diagrams. Figure 20 shows the differences between DQ2 and DQ6 in graphical form. See also the subsection on DQ2: Toggle Bit II.



**Note:** The system should recheck the toggle bit even if  $DQ5 = "1"$  because the toggle bit may stop toggling as  $DQ5$  changes to "1." See the subsections on DQ6 and DQ2 for more information.

**Figure 6. Toggle Bit Algorithm**

## DQ2: Toggle Bit II

The “Toggle Bit II” on DQ2, when used with DQ6, indicates whether a particular sector is actively erasing (that is, the Embedded Erase algorithm is in progress), or whether that sector is erase-suspended. Toggle Bit II is valid after the rising edge of the final WE# pulse in the command sequence.

DQ2 toggles when the system reads at addresses within those sectors that have been selected for erasure. (The system may use either OE# or CE# or CE2# to control the read cycles.) But DQ2 cannot distinguish whether the sector is actively erasing or is erase-suspended. DQ6, by comparison, indicates whether the device is actively erasing, or is in Erase Suspend, but cannot distinguish which sectors are selected for erasure. Thus, both status bits are required for sector and mode information. Refer to Table 11 to compare outputs for DQ2 and DQ6.

Figure 6 shows the toggle bit algorithm in flowchart form, and the section “DQ2: Toggle Bit II” explains the algorithm. See also the DQ6: Toggle Bit I subsection. Figure 19 shows the toggle bit timing diagram. Figure 20 shows the differences between DQ2 and DQ6 in graphical form.

## Reading Toggle Bits DQ6/DQ2

Refer to Figure 6 for the following discussion. Whenever the system initially begins reading toggle bit status, it must read DQ7–DQ0 at least twice in a row to determine whether a toggle bit is toggling. Typically, the system would note and store the value of the toggle bit after the first read. After the second read, the system would compare the new value of the toggle bit with the first. If the toggle bit is not toggling, the device has completed the program or erase operation. The system can read array data on DQ7–DQ0 on the following read cycle.

However, if after the initial two read cycles, the system determines that the toggle bit is still toggling, the system also should note whether the value of DQ5 is high (see the section on DQ5). If it is, the system should then determine again whether the toggle bit is toggling, since the toggle bit may have stopped toggling just as DQ5 went high. If the toggle bit is no longer toggling, the device has successfully completed the program or erase operation. If it is still toggling, the device did not complete the operation successfully, and the system must write the reset command to return to reading array data.

The remaining scenario is that the system initially determines that the toggle bit is toggling and DQ5 has not gone high. The system may continue to monitor

the toggle bit and DQ5 through successive read cycles, determining the status as described in the previous paragraph. Alternatively, it may choose to perform other system tasks. In this case, the system must start at the beginning of the algorithm when it returns to determine the status of the operation (top of Figure 6).

## DQ5: Exceeded Timing Limits

DQ5 indicates whether the program or erase time has exceeded a specified internal pulse count limit. Under these conditions DQ5 produces a “1,” indicating that the program or erase cycle was not successfully completed.

The device may output a “1” on DQ5 if the system tries to program a “1” to a location that was previously programmed to “0.” **Only an erase operation can change a “0” back to a “1.”** Under this condition, the device halts the operation, and when the timing limit has been exceeded, DQ5 produces a “1.”

Under both these conditions, the system must write the reset command to return to the read mode (or to the erase-suspend-read mode if the device was previously in the erase-suspend-program mode).

## DQ3: Sector Erase Timer

After writing a sector erase command sequence, the system may read DQ3 to determine whether or not erasure has begun. (The sector erase timer does not apply to the chip erase command.) If additional sectors are selected for erasure, the entire time-out also applies after each additional sector erase command. When the time-out period is complete, DQ3 switches from a “0” to a “1.” If the time between additional sector erase commands from the system can be assumed to be less than 50  $\mu$ s, the system need not monitor DQ3. See also the Sector Erase Command Sequence section.

After the sector erase command is written, the system should read the status of DQ7 (Data# Polling) or DQ6 (Toggle Bit I) to ensure that the device has accepted the command sequence, and then read DQ3. If DQ3 is “1,” the Embedded Erase algorithm has begun; all further commands (except Erase Suspend) are ignored until the erase operation is complete. If DQ3 is “0,” the device will accept additional sector erase commands. To ensure the command has been accepted, the system software should check the status of DQ3 prior to and following each subsequent sector erase command. If DQ3 is high on the second status check, the last command might not have been accepted.

Table 11 shows the status of DQ3 relative to the other status bits.

Table 11. Write Operation Status

| Status             |                            |                            | DQ7<br>(Note 2) | DQ6       | DQ5<br>(Note 1) | DQ3  | DQ2<br>(Note 2) | RY/BY# |
|--------------------|----------------------------|----------------------------|-----------------|-----------|-----------------|------|-----------------|--------|
| Standard Mode      | Embedded Program Algorithm |                            | DQ7#            | Toggle    | 0               | N/A  | No toggle       | 0      |
|                    | Embedded Erase Algorithm   |                            | 0               | Toggle    | 0               | 1    | Toggle          | 0      |
| Erase Suspend Mode | Erase-Suspend-Read         | Erase Suspended Sector     | 1               | No toggle | 0               | N/A  | Toggle          | 1      |
|                    |                            | Non-Erase Suspended Sector | Data            | Data      | Data            | Data | Data            | 1      |
|                    | Erase-Suspend-Program      |                            | DQ7#            | Toggle    | 0               | N/A  | N/A             | 0      |

**Notes:**

1. DQ5 switches to '1' when an Embedded Program or Embedded Erase operation has exceeded the maximum timing limits. Refer to the section on DQ5 for more information.
2. DQ7 and DQ2 require a valid address when reading status information. Refer to the appropriate subsection for further details.

**ABSOLUTE MAXIMUM RATINGS**

Storage Temperature

Plastic Packages . . . . .  $-65^{\circ}\text{C}$  to  $+150^{\circ}\text{C}$ 

Ambient Temperature

with Power Applied. . . . .  $-65^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$ 

Voltage with Respect to Ground

 $V_{\text{CC}}$  (Note 1) . . . . .  $-0.5\text{ V}$  to  $+4.0\text{ V}$  $V_{\text{IO}}$  . . . . .  $-0.5\text{ V}$  to  $+5.5\text{ V}$ 

A9, OE#, ACC, and RESET#

(Note 2) . . . . .  $-0.5\text{ V}$  to  $+12.5\text{ V}$ All other pins (Note 1) . . . . .  $-0.5\text{ V}$  to  $V_{\text{CC}} + 0.5\text{ V}$ 

Output Short Circuit Current (Note 3) . . . . . 200 mA

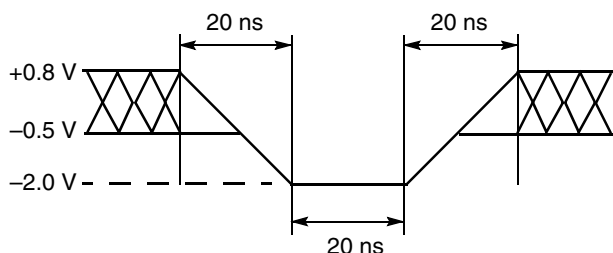
**Notes:**

1. Minimum DC voltage on input or I/O pins is  $-0.5\text{ V}$ . During voltage transitions, input or I/O pins may overshoot  $V_{\text{SS}}$  to  $-2.0\text{ V}$  for periods of up to 20 ns. Maximum DC voltage on input or I/O pins is  $V_{\text{CC}} + 0.5\text{ V}$ . See Figure 7. During voltage transitions, input or I/O pins may overshoot to  $V_{\text{CC}} + 2.0\text{ V}$  for periods up to 20 ns. See Figure 8.
2. Minimum DC input voltage on pins A9, OE#, ACC, and RESET# is  $-0.5\text{ V}$ . During voltage transitions, A9, OE#, ACC, and RESET# may overshoot  $V_{\text{SS}}$  to  $-2.0\text{ V}$  for periods of up to 20 ns. See Figure 7. Maximum DC input voltage on pin A9, OE#, ACC, and RESET# is  $+12.5\text{ V}$  which may overshoot to  $+14.0\text{ V}$  for periods up to 20 ns.
3. No more than one output may be shorted to ground at a time. Duration of the short circuit should not be greater than one second.

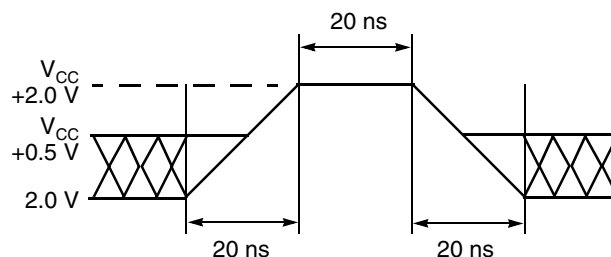
Stresses above those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this data sheet is not implied. Exposure of the device to absolute maximum rating conditions for extended periods may affect device reliability.

**OPERATING RANGES****Industrial (I) Devices**Ambient Temperature ( $T_A$ ) . . . . .  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ **Extended (E) Devices**Ambient Temperature ( $T_A$ ) . . . . .  $-55^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  **$V_{\text{CC}}$  Supply Voltages** $V_{\text{CC}}$  for all devices . . . . . 3.0 V to 3.6 V

Operating ranges define those limits between which the functionality of the device is guaranteed.



**Figure 7. Maximum Negative Overshoot Waveform**



**Figure 8. Maximum Positive Overshoot Waveform**

# DC CHARACTERISTICS

## (For Two Am29LV640 Devices)

### CMOS Compatible

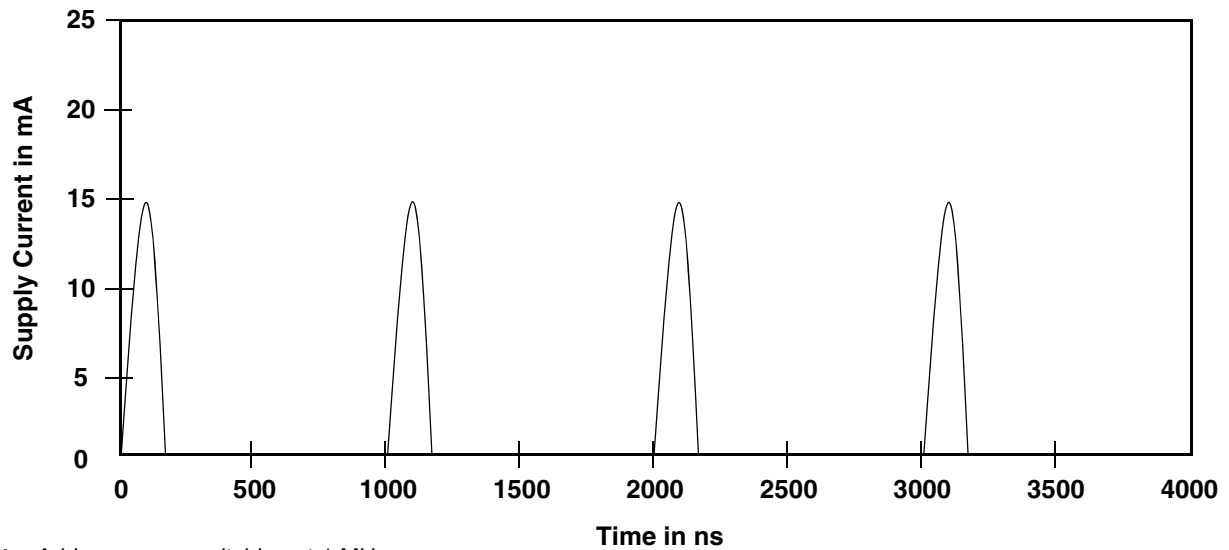
| Parameter Symbol | Parameter Description                                 | Test Conditions                                             | Min                 | Typ | Max            | Unit    |
|------------------|-------------------------------------------------------|-------------------------------------------------------------|---------------------|-----|----------------|---------|
| $I_{LI}$         | Input Load Current                                    | $V_{IN} = V_{SS}$ to $V_{CC}$ ,<br>$V_{CC} = V_{CC\ max}$   |                     |     | $\pm 1.0$      | $\mu A$ |
| $I_{LIT}$        | A9, ACC Input Load Current                            | $V_{CC} = V_{CC\ max}$ ; A9 = 12.5 V                        |                     |     | 70             | $\mu A$ |
| $I_{LO}$         | Output Leakage Current                                | $V_{OUT} = V_{SS}$ to $V_{CC}$ ,<br>$V_{CC} = V_{CC\ max}$  |                     |     | $\pm 1.0$      | $\mu A$ |
| $I_{CC1}$        | $V_{CC}$ Active Read Current (Notes 1, 2)             | CE# (or CE2#) = $V_{IL}$ ,<br>OE# = $V_{IH}$                | 5 MHz               | 9   | 16             | mA      |
|                  |                                                       |                                                             | 1 MHz               | 2   | 4              |         |
| $I_{CC2}$        | $V_{CC}$ Active Write Current (Notes 2, 3, 4)         | CE# (or CE2#) = $V_{IL}$ , OE# = $V_{IH}$                   |                     | 26  | 30             | mA      |
| $I_{CC3}$        | $V_{CC}$ Standby Current (Note 2)                     | CE#, CE2#, RESET# = $V_{CC} \pm 0.3\ V$                     |                     | 0.4 | 10             | $\mu A$ |
| $I_{CC4}$        | $V_{CC}$ Reset Current (Note 2)                       | RESET# = $V_{SS} \pm 0.3\ V$                                |                     | 0.4 | 10             | $\mu A$ |
| $I_{CC5}$        | Automatic Sleep Mode (Notes 2, 5)                     | $V_{IH} = V_{CC} \pm 0.3\ V$ ; $V_{IL} = V_{SS} \pm 0.3\ V$ |                     | 0.4 | 10             | $\mu A$ |
| $I_{ACC}$        | ACC Accelerated Program Current (Note 4)              | CE# = $V_{IL}$ , OE# = $V_{IH}$                             | ACC pin             | 5   | 10             | mA      |
|                  |                                                       |                                                             | $V_{CC}$ pin        | 15  | 30             | mA      |
| $V_{IL}$         | Input Low Voltage (Note 6)                            |                                                             | -0.5                |     | 0.8            | V       |
| $V_{IH}$         | Input High Voltage (Note 6)                           |                                                             | $0.7 \times V_{CC}$ |     | $V_{CC} + 0.3$ | V       |
| $V_{HH}$         | Voltage for ACC Program Acceleration                  | $V_{CC} = 3.0\ V \pm 10\%$                                  | 11.5                |     | 12.5           | V       |
| $V_{ID}$         | Voltage for Autoselect and Temporary Sector Unprotect | $V_{CC} = 3.0\ V \pm 10\%$                                  | 8.5                 |     | 12.5           | V       |
| $V_{OL}$         | Output Low Voltage                                    | $I_{OL} = 4.0\ mA$ , $V_{CC} = V_{CC\ min}$                 |                     |     | 0.45           | V       |
| $V_{OH1}$        | Output High Voltage (Note 7)                          | $I_{OH} = -2.0\ mA$ , $V_{CC} = V_{CC\ min}$                | $0.85 V_{IO}$       |     |                | V       |
| $V_{OH2}$        |                                                       | $I_{OH} = -100\ \mu A$ , $V_{CC} = V_{CC\ min}$             | $V_{IO} - 0.4$      |     |                | V       |
| $V_{LKO}$        | Low $V_{CC}$ Lock-Out Voltage (Note 7)                |                                                             | 2.3                 |     | 2.5            | V       |

#### Notes:

1. The  $I_{CC}$  current listed is typically less than 2 mA/MHz, with OE# at  $V_{IH}$ .
2. Maximum  $I_{CC}$  specifications are tested with  $V_{CC} = V_{CC\ max}$ .
3.  $I_{CC}$  active while Embedded Erase or Embedded Program is in progress.
4. Assumes only one Am29LV640 die being programmed at the same time.
5. Automatic sleep mode enables the low power mode when addresses remain stable for  $t_{ACC} + 30\ ns$ . Typical sleep mode current is 400 nA.
6. If  $V_{IO} < V_{CC}$ , maximum  $V_{IL}$  for CE# (or CE2#) is  $0.3 V_{IO}$ . If  $V_{IO} < V_{CC}$ , minimum  $V_{IH}$  for CE# (or CE2#) is  $0.3 V_{IO}$ .
7. Not 100% tested.
8. CE# can be replaced with CE2# when referring to the second device within the package.
9. Specifications in the table are for the Am29LV642 i.e. two Am29LV640 dice unless otherwise noted.

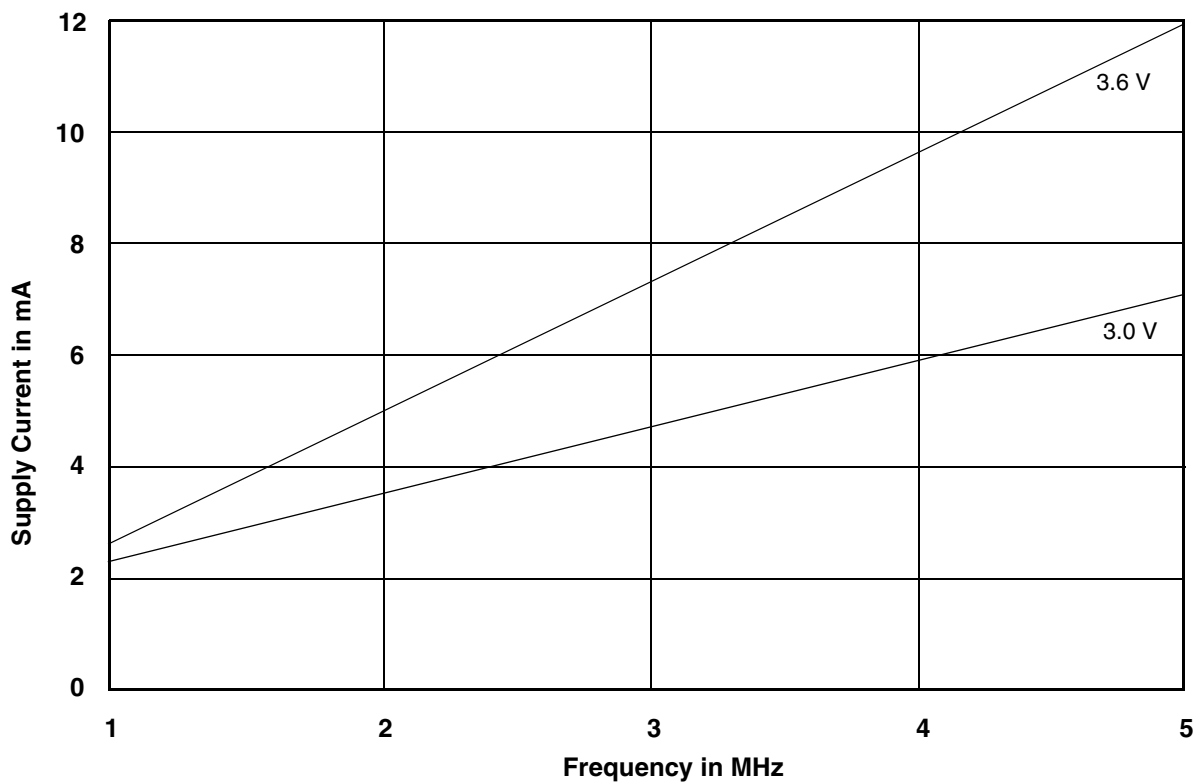
## DC CHARACTERISTICS

## Zero-Power Flash



**Note:** Addresses are switching at 1 MHz

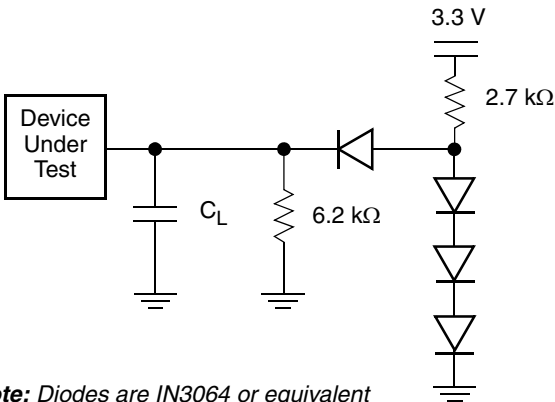
**Figure 9.  $I_{CC1}$  Current vs. Time (Showing Active and Automatic Sleep Currents)**



**Note:**  $T = 25^{\circ}\text{C}$

**Figure 10. Typical  $I_{CC1}$  vs. Frequency**

TEST CONDITIONS



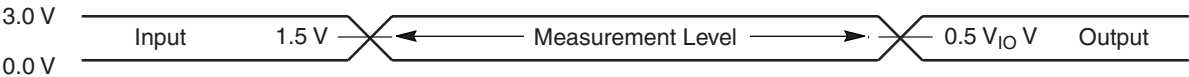
**Note:** Diodes are IN3064 or equivalent

**Figure 11. Test Setup**

**Table 12. Test Specifications**

| Test Condition                                                | 90R          | 12R | Unit |
|---------------------------------------------------------------|--------------|-----|------|
| Output Load                                                   | 1 TTL gate   |     |      |
| Output Load Capacitance, $C_L$<br>(including jig capacitance) | 30           | 100 | pF   |
| Input Rise and Fall Times                                     | 5            |     | ns   |
| Input Pulse Levels                                            | 0.0–3.0      |     | V    |
| Input timing measurement<br>reference levels (See Note)       | 1.5          |     | V    |
| Output timing measurement<br>reference levels                 | $0.5 V_{IO}$ |     | V    |

**Note:** If  $V_{IO} < V_{CC}$ , the reference level is  $0.5 V_{IO}$ .



**Note:** If  $V_{IO} < V_{CC}$ , the input measurement reference level is  $0.5 V_{IO}$ .

**Figure 12. Input Waveforms and Measurement Levels**

KEY TO SWITCHING WAVEFORMS

| WAVEFORM | INPUTS                           | OUTPUTS                                      |
|----------|----------------------------------|----------------------------------------------|
|          | Steady                           |                                              |
|          | Changing from H to L             |                                              |
|          | Changing from L to H             |                                              |
|          | Don't Care, Any Change Permitted | Changing, State Unknown                      |
|          | Does Not Apply                   | Center Line is High Impedance State (High Z) |



## AC CHARACTERISTICS

## Read-Only Operations

| Parameter  |           | Description                                                         | Test Setup<br>(Note 1)   |     | Speed Options |     | Unit |
|------------|-----------|---------------------------------------------------------------------|--------------------------|-----|---------------|-----|------|
| JEDEC      | Std.      |                                                                     |                          |     | 90R           | 12R |      |
| $t_{AVAV}$ | $t_{RC}$  | Read Cycle Time (Note 2)                                            |                          | Min | 90            | 120 | ns   |
| $t_{AVQV}$ | $t_{ACC}$ | Address to Output Delay                                             | CE#, OE# = $V_{IL}$      | Max | 90            | 120 | ns   |
| $t_{ELQV}$ | $t_{CE}$  | Chip Enable to Output Delay                                         | OE# = $V_{IL}$           | Max | 90            | 120 | ns   |
| $t_{GLQV}$ | $t_{OE}$  | Output Enable to Output Delay                                       |                          | Max | 35            | 50  | ns   |
| $t_{EHQZ}$ | $t_{DF}$  | Chip Enable to Output High Z (Note 2)                               |                          | Max | 30            | 30  | ns   |
| $t_{GHQZ}$ | $t_{DF}$  | Output Enable to Output High Z (Note 2)                             |                          | Max | 30            | 30  | ns   |
| $t_{AXQX}$ | $t_{OH}$  | Output Hold Time From Addresses, CE# or OE#, Whichever Occurs First |                          | Min | 0             |     | ns   |
|            | $t_{OEh}$ | Output Enable Hold Time (Note 2)                                    | Read                     | Min | 0             |     | ns   |
|            |           |                                                                     | Toggle and Data# Polling | Min | 10            |     | ns   |

**Notes:**

1. All test setups assume  $V_{IO} = V_{CC}$ .
2. Not 100% tested.
3. See Figure 11 and Table 12 for test specifications
4. CE# can be replaced with CE2# when referring to the second device within the package.

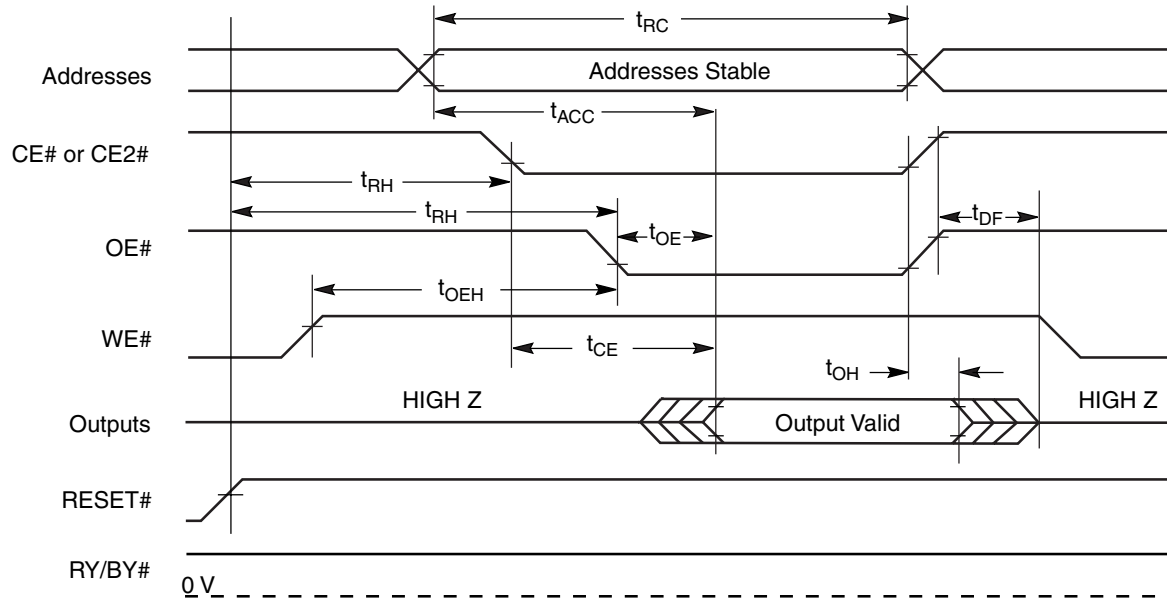


Figure 13. Read Operation Timings

## AC CHARACTERISTICS

## Hardware Reset (RESET#)

| Parameter |                    | Description                                                             |     | All Speed Options | Unit          |
|-----------|--------------------|-------------------------------------------------------------------------|-----|-------------------|---------------|
| JEDEC     | Std                |                                                                         |     |                   |               |
|           | $t_{\text{Ready}}$ | RESET# Pin Low (During Embedded Algorithms) to Read Mode (See Note)     | Max | 20                | $\mu\text{s}$ |
|           | $t_{\text{Ready}}$ | RESET# Pin Low (NOT During Embedded Algorithms) to Read Mode (See Note) | Max | 500               | ns            |
|           | $t_{\text{RP}}$    | RESET# Pulse Width                                                      | Min | 500               | ns            |
|           | $t_{\text{RH}}$    | Reset High Time Before Read (See Note)                                  | Min | 50                | ns            |
|           | $t_{\text{RPD}}$   | RESET# Low to Standby Mode                                              | Min | 20                | $\mu\text{s}$ |
|           | $t_{\text{RB}}$    | RY/BY# Recovery Time                                                    | Min | 0                 | ns            |

**Note:** Not 100% tested.

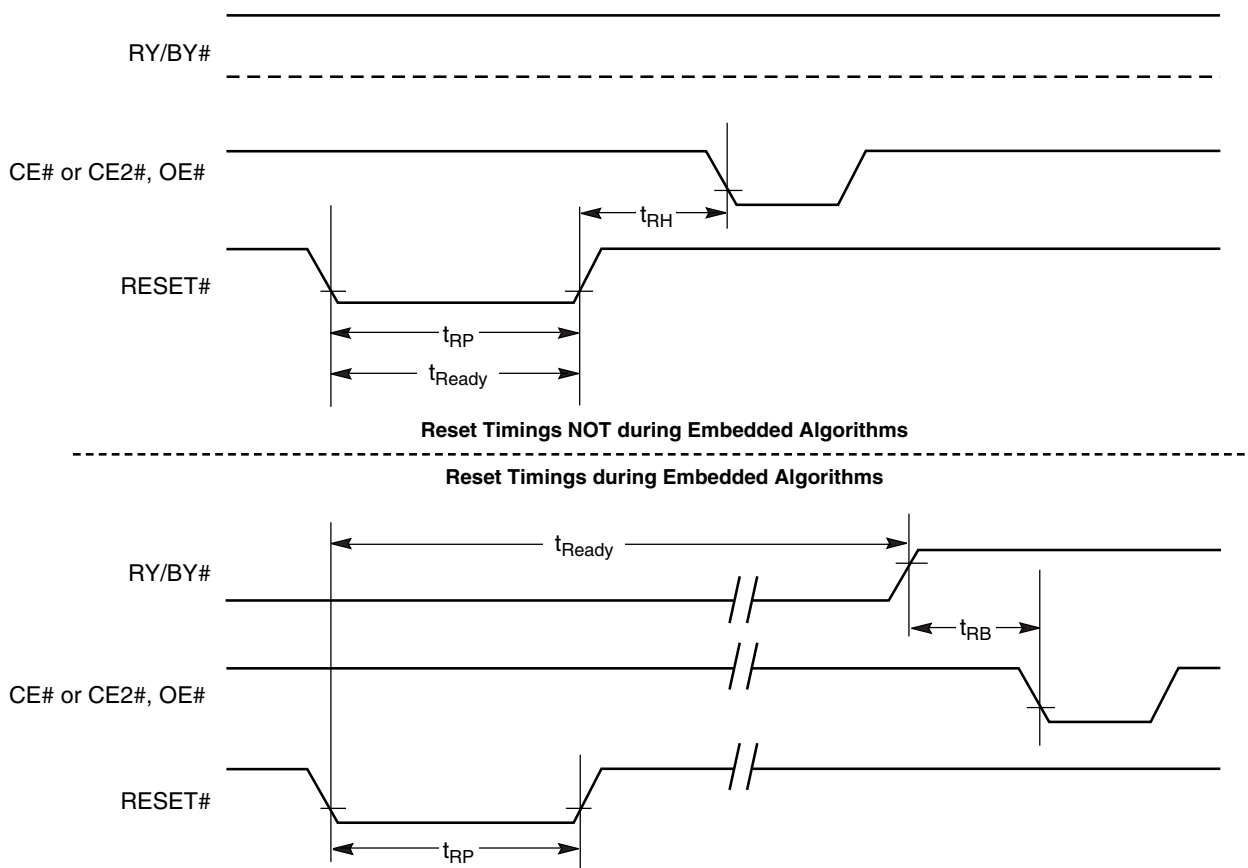


Figure 14. Reset Timings

## AC CHARACTERISTICS

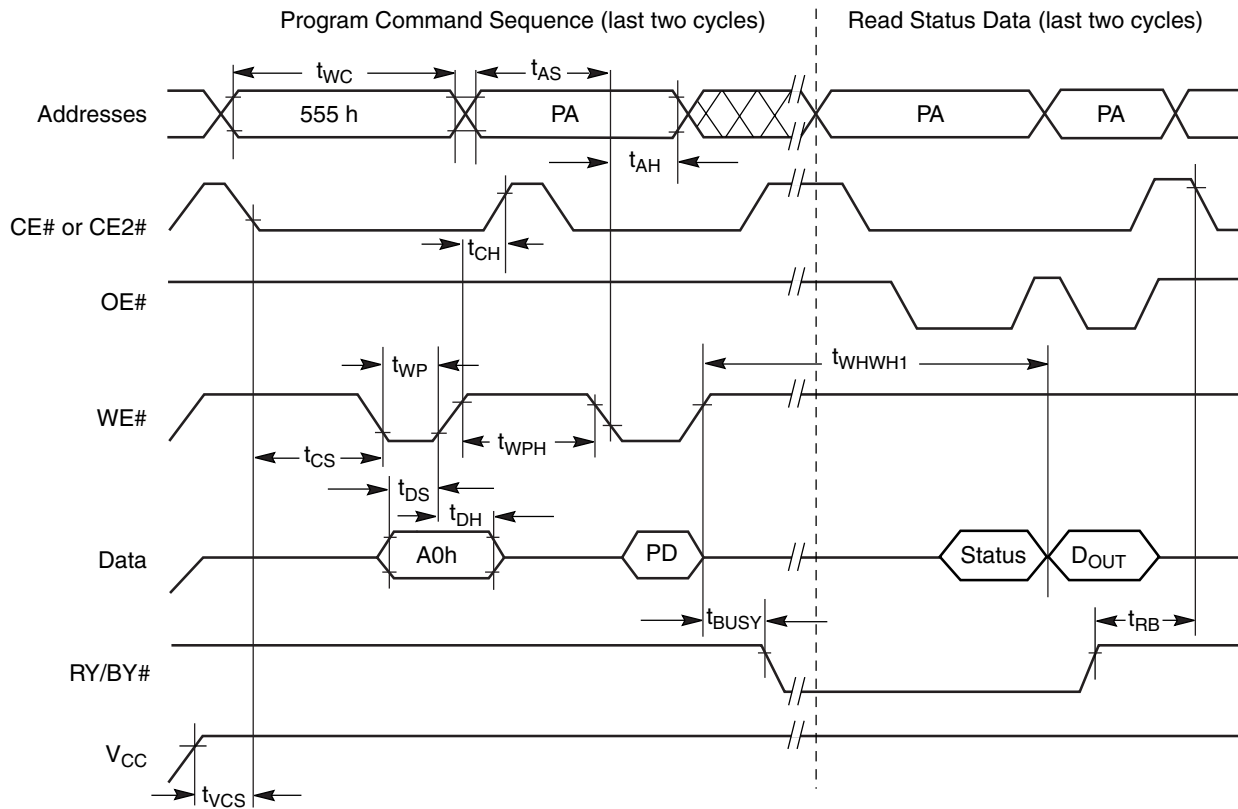
## Erase and Program Operations

| Parameter   |             | Description                                                      |     | Speed Options |     | Unit    |
|-------------|-------------|------------------------------------------------------------------|-----|---------------|-----|---------|
| JEDEC       | Std.        |                                                                  |     | 90R           | 12R |         |
| $t_{AVAV}$  | $t_{WC}$    | Write Cycle Time (Note 1)                                        | Min | 90            | 120 | ns      |
| $t_{AVWL}$  | $t_{AS}$    | Address Setup Time                                               | Min | 0             |     | ns      |
|             | $t_{ASO}$   | Address Setup Time to OE# low during toggle bit polling          | Min | 15            |     | ns      |
| $t_{WLAX}$  | $t_{AH}$    | Address Hold Time                                                | Min | 45            | 50  | ns      |
|             | $t_{AHT}$   | Address Hold Time From CE# or OE# high during toggle bit polling | Min | 0             |     | ns      |
| $t_{DVWH}$  | $t_{DS}$    | Data Setup Time                                                  | Min | 45            | 50  | ns      |
| $t_{WHDX}$  | $t_{DH}$    | Data Hold Time                                                   | Min | 0             |     | ns      |
|             | $t_{OEPH}$  | Output Enable High during toggle bit polling                     | Min | 20            |     | ns      |
| $t_{GHWL}$  | $t_{GHWL}$  | Read Recovery Time Before Write (OE# High to WE# Low)            | Min | 0             |     | ns      |
| $t_{ELWL}$  | $t_{CS}$    | CE# Setup Time                                                   | Min | 0             |     | ns      |
| $t_{WHEH}$  | $t_{CH}$    | CE# Hold Time                                                    | Min | 0             |     | ns      |
| $t_{WLWH}$  | $t_{WP}$    | Write Pulse Width                                                | Min | 35            | 50  | ns      |
| $t_{WHDL}$  | $t_{WPH}$   | Write Pulse Width High                                           | Min | 30            |     | ns      |
| $t_{WHWH1}$ | $t_{WHWH1}$ | Word Programming Operation (Note 2)                              | Typ | 11            |     | $\mu$ s |
| $t_{WHWH1}$ | $t_{WHWH1}$ | Accelerated Word Programming Operation (Note 2)                  | Typ | 7             |     | $\mu$ s |
| $t_{WHWH2}$ | $t_{WHWH2}$ | Sector Erase Operation (Note 2)                                  | Typ | 1.6           |     | sec     |
|             | $t_{VHH}$   | $V_{HH}$ Rise and Fall Time (Note 1)                             | Min | 250           |     | ns      |
|             | $t_{VCS}$   | $V_{CC}$ Setup Time (Note 1)                                     | Min | 50            |     | $\mu$ s |
|             | $t_{RB}$    | Write Recovery Time from RY/BY#                                  | Min | 0             |     | ns      |
|             | $t_{BUSY}$  | Program/Erase Valid to RY/BY# Delay                              | Min | 90            |     | ns      |

**Notes:**

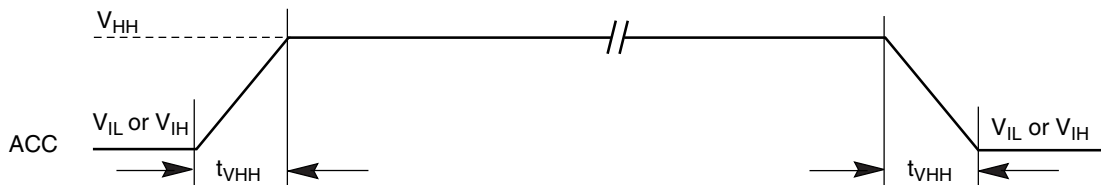
1. Not 100% tested.
2. See the "Erase And Programming Performance" section for more information.
3. CE# can be replaced with CE2# when referring to the second device within the package.

## AC CHARACTERISTICS



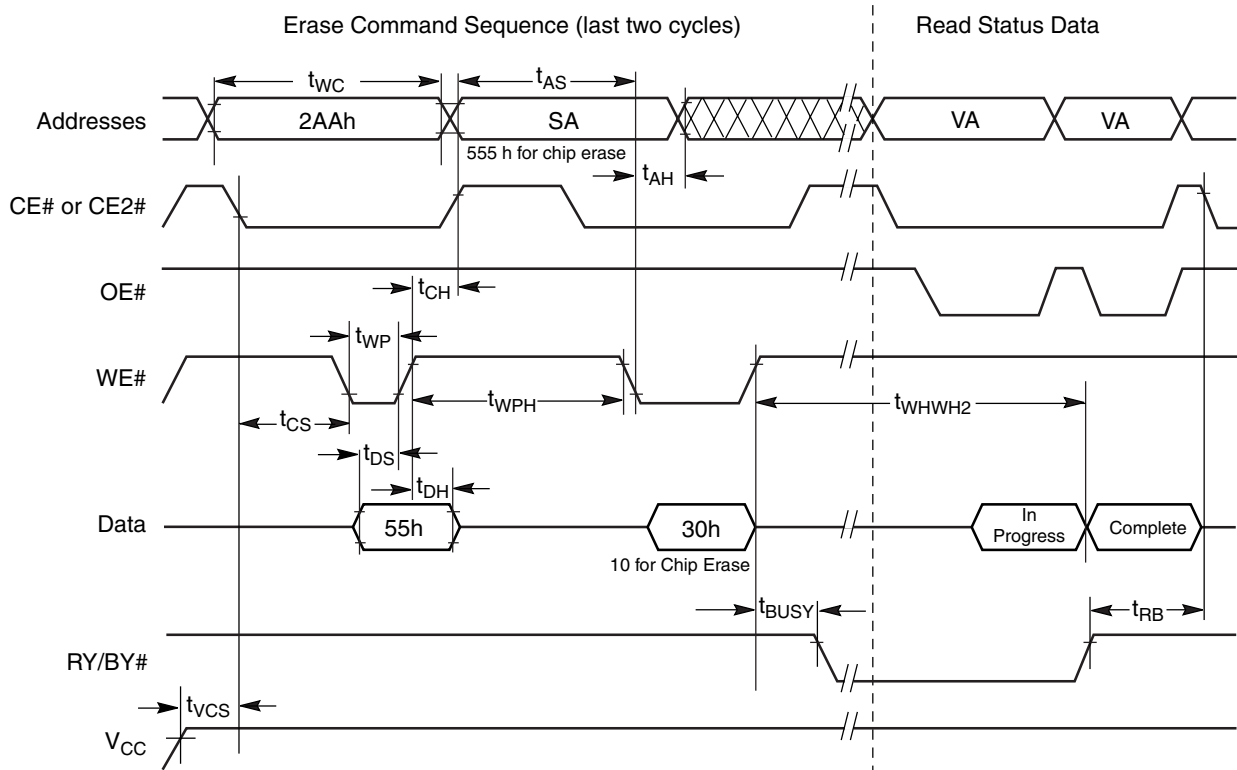
**Note:** PA = program address, PD = program data,  $D_{OUT}$  is the true data at the program address.

**Figure 15. Program Operation Timings**



**Figure 16. Accelerated Program Timing Diagram**

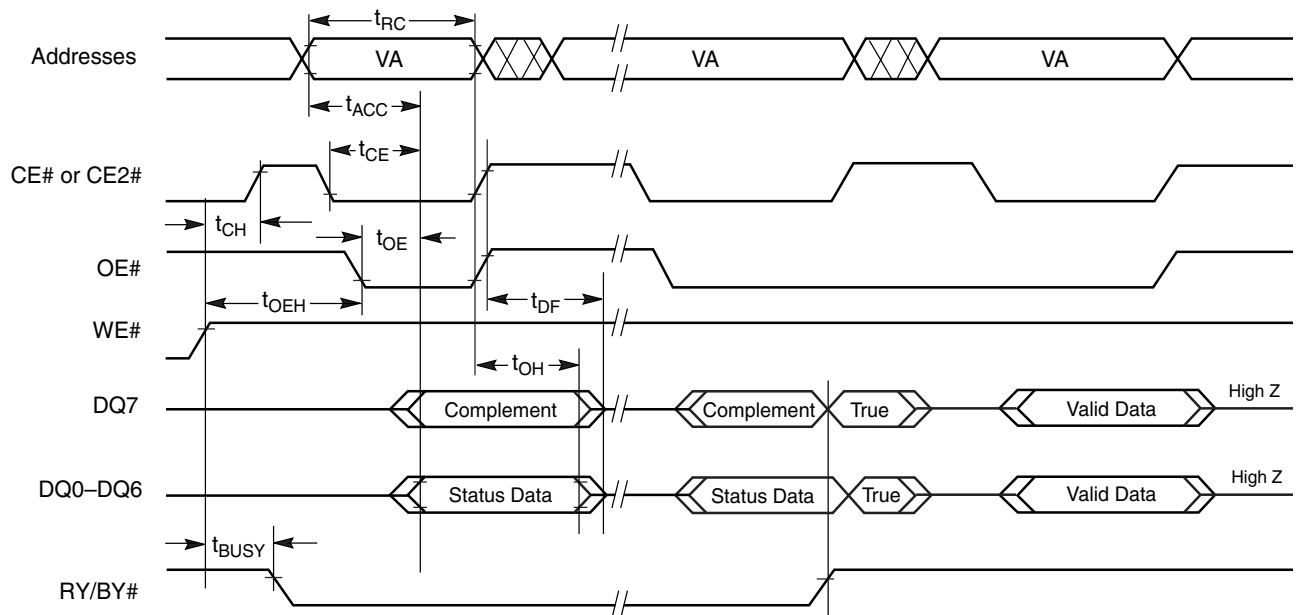
## AC CHARACTERISTICS



**Note:** SA = sector address (for Sector Erase), VA = Valid Address for reading status data (see "Write Operation Status").

**Figure 17. Chip/Sector Erase Operation Timings**

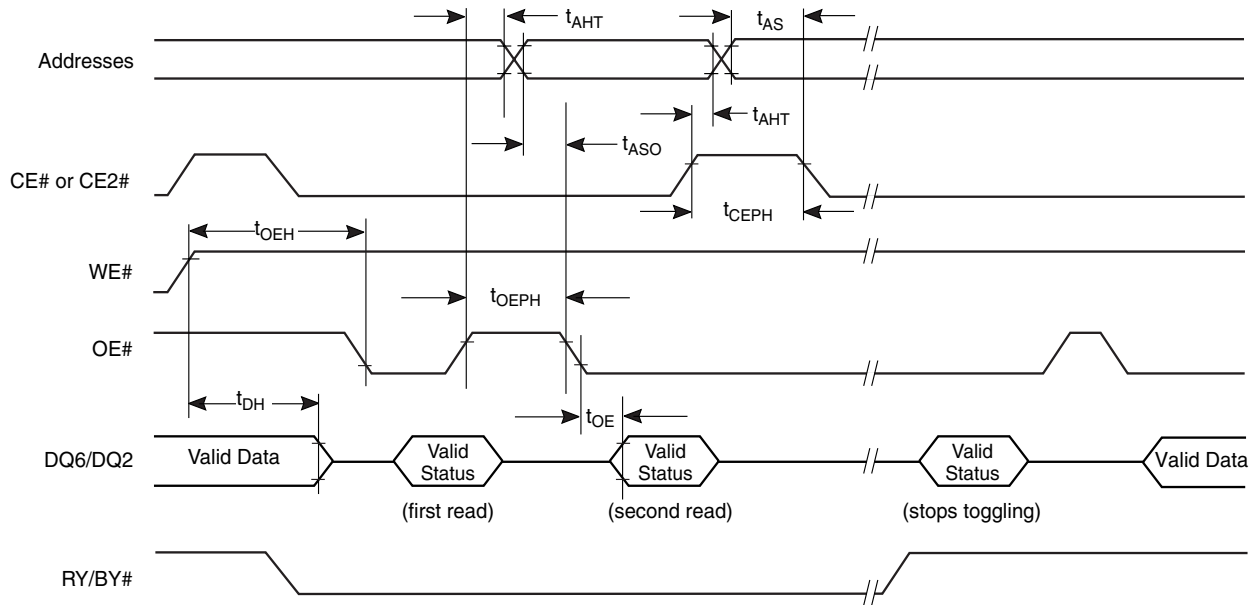
## AC CHARACTERISTICS



**Note:** VA = Valid address. Illustration shows first status cycle after command sequence, last status read cycle, and array data read cycle.

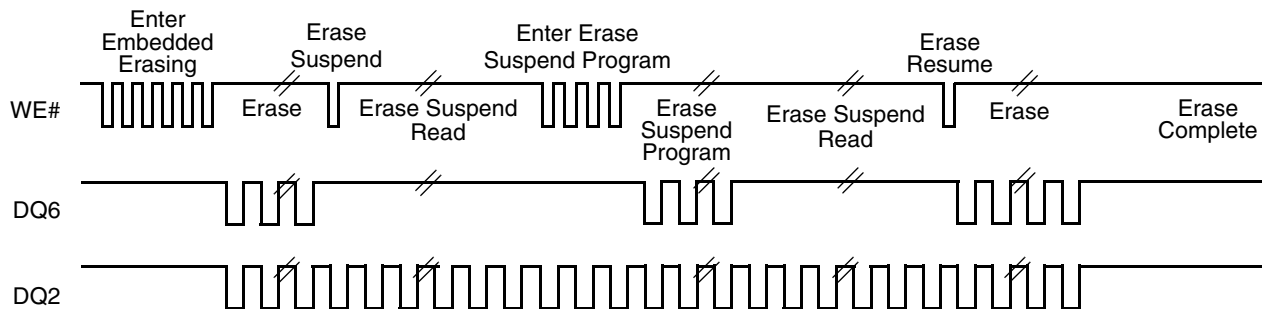
**Figure 18. Data# Polling Timings (During Embedded Algorithms)**

## AC CHARACTERISTICS



**Note:** VA = Valid address; not required for DQ6. Illustration shows first two status cycle after command sequence, last status read cycle, and array data read cycle

**Figure 19. Toggle Bit Timings (During Embedded Algorithms)**



**Note:** DQ2 toggles only when read at an address within an erase-suspended sector. The system may use OE# or CE# to toggle DQ2 and DQ6.

**Figure 20. DQ2 vs. DQ6**

## AC CHARACTERISTICS

## Temporary Sector Unprotect

| Parameter |            | Description                                                            |     | All Speed Options | Unit    |
|-----------|------------|------------------------------------------------------------------------|-----|-------------------|---------|
| JEDEC     | Std        |                                                                        |     |                   |         |
|           | $t_{VIDR}$ | $V_{ID}$ Rise and Fall Time (See Note)                                 | Min | 500               | ns      |
|           | $t_{RSP}$  | RESET# Setup Time for Temporary Sector Unprotect                       | Min | 4                 | $\mu$ s |
|           | $t_{RRB}$  | RESET# Hold Time from RY/BY# High for Temporary Sector Group Unprotect | Min | 4                 | $\mu$ s |

**Note:** Not 100% tested.

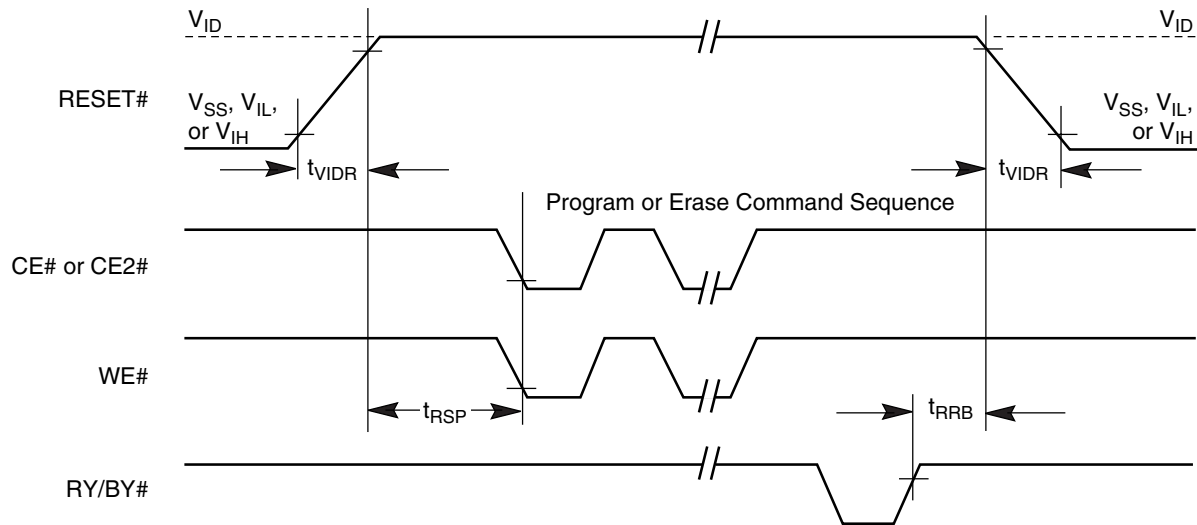
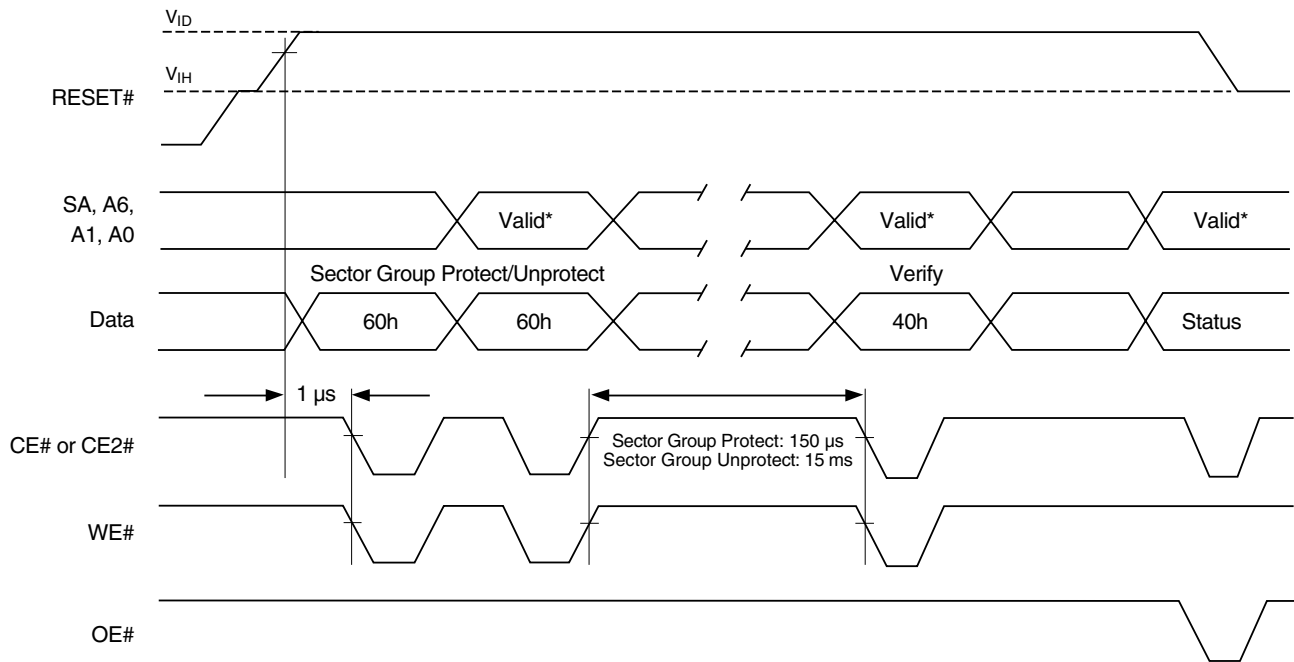


Figure 21. Temporary Sector Group Unprotect Timing Diagram



## AC CHARACTERISTICS



\* For sector group protect,  $A6 = 0, A1 = 1, A0 = 0$ . For sector group unprotect,  $A6 = 1, A1 = 1, A0 = 0$ .

**Figure 22. Sector Group Protect and Unprotect Timing Diagram**

## AC CHARACTERISTICS

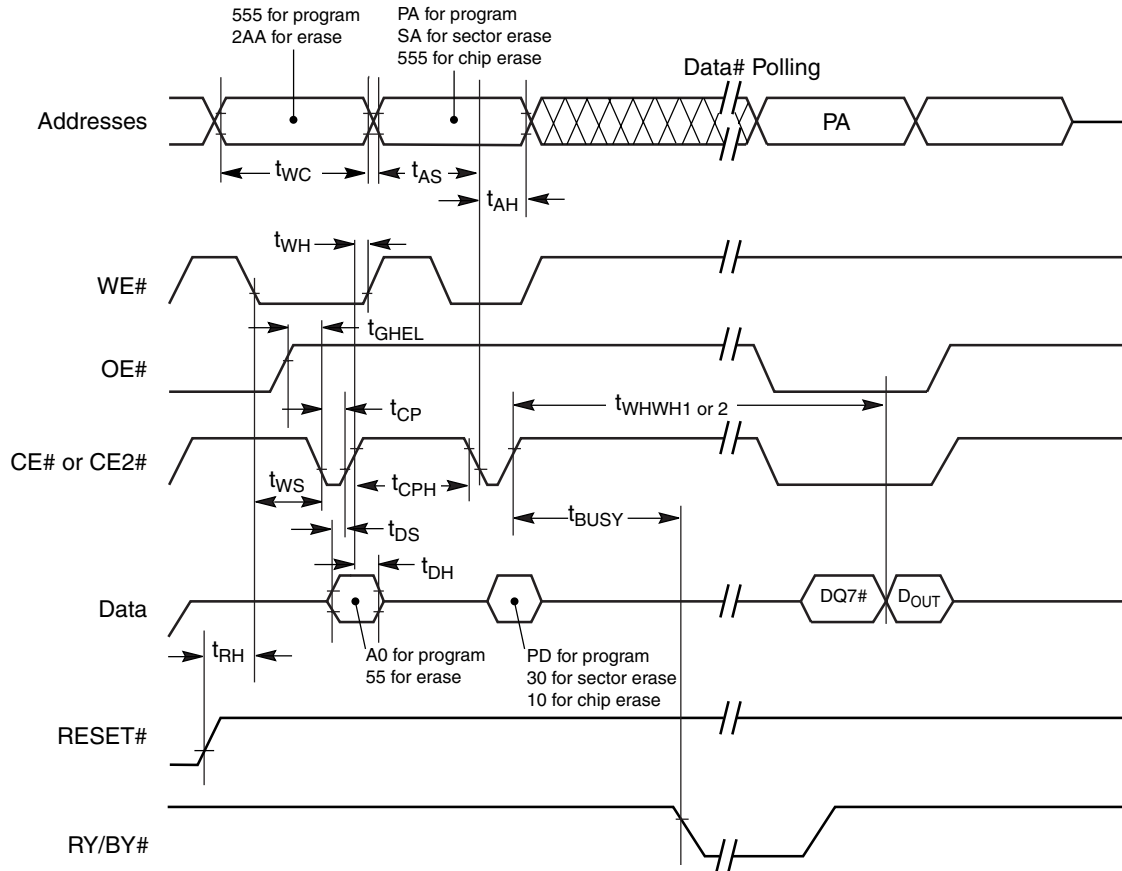
## Alternate CE# Controlled Erase and Program Operations

| Parameter             |                       | Description                                              |     | Speed Options |     | Unit    |
|-----------------------|-----------------------|----------------------------------------------------------|-----|---------------|-----|---------|
| JEDEC                 | Std                   |                                                          |     | 90R           | 12R |         |
| $t_{AVAV}$            | $t_{WC}$              | Write Cycle Time (Note 1)                                | Min | 90            | 120 | ns      |
| $t_{AVWL}$            | $t_{AS}$              | Address Setup Time                                       | Min | 0             |     | ns      |
| $t_{ELAX}$            | $t_{AH}$              | Address Hold Time                                        | Min | 45            | 50  | ns      |
| $t_{DVEH}$            | $t_{DS}$              | Data Setup Time                                          | Min | 45            | 50  | ns      |
| $t_{EHDX}$            | $t_{DH}$              | Data Hold Time                                           | Min | 0             |     | ns      |
| $t_{GH\overline{EL}}$ | $t_{GH\overline{EL}}$ | Read Recovery Time Before Write<br>(OE# High to WE# Low) | Min | 0             |     | ns      |
| $t_{WLEL}$            | $t_{WS}$              | WE# Setup Time                                           | Min | 0             |     | ns      |
| $t_{EHWH}$            | $t_{WH}$              | WE# Hold Time                                            | Min | 0             |     | ns      |
| $t_{ELEH}$            | $t_{CP}$              | CE# Pulse Width                                          | Min | 45            | 50  | ns      |
| $t_{EHEL}$            | $t_{CPH}$             | CE# Pulse Width High                                     | Min | 30            |     | ns      |
| $t_{WHWH1}$           | $t_{WHWH1}$           | Word Programming Operation (Note 2)                      | Typ | 11            |     | $\mu$ s |
| $t_{WHWH1}$           | $t_{WHWH1}$           | Accelerated Word Programming Operation (Note 2)          | Typ | 7             |     | $\mu$ s |
| $t_{WHWH2}$           | $t_{WHWH2}$           | Sector Erase Operation (Note 2)                          | Typ | 1.6           |     | sec     |

**Notes:**

1. Not 100% tested.
2. See the "Erase And Programming Performance" section for more information.
3. CE# can be replaced with CE2# when referring to the second device within the package.

## AC CHARACTERISTICS

**Notes:**

1. Figure indicates last two bus cycles of a program or erase operation.
2. PA = program address, SA = sector address, PD = program data.
3. DQ7# is the complement of the data written to the device. D<sub>OUT</sub> is the data written to the device.

**Figure 23. Alternate CE# Controlled Write (Erase/Program) Operation Timings**

## ERASE AND PROGRAMMING PERFORMANCE

| Parameter                     | Typ (Note 1) | Max (Note 2) | Unit    | Comments                                           |
|-------------------------------|--------------|--------------|---------|----------------------------------------------------|
| Sector Erase Time             | 1.6          | 15           | sec     | Excludes 00h programming prior to erasure (Note 4) |
| Chip Erase Time               | 90           |              | sec     |                                                    |
| Word Program Time             | 11           | 300          | $\mu$ s | Excludes system level overhead (Note 5)            |
| Accelerated Word Program Time | 7            | 210          | $\mu$ s |                                                    |
| Chip Program Time (Note 3)    | 48           | 144          | sec     |                                                    |

**Notes:**

1. Typical program and erase times assume the following conditions: 25°C, 3.0 V  $V_{CC}$ , 1,000,000 cycles. Additionally, programming typicals assume checkerboard pattern.
2. Under worst case conditions of 90°C,  $V_{CC} = 3.0$  V, 1,000,000 cycles.
3. The typical chip programming time is considerably less than the maximum chip programming time listed, since most words program faster than the maximum program times listed.
4. In the pre-programming step of the Embedded Erase algorithm, all bits are programmed to 00h before erasure.
5. System-level overhead is the time required to execute the two- or four-bus-cycle sequence for the program command. See Table 10 for further information on command definitions.
6. The device has a minimum erase and program cycle endurance of 1,000,000 cycles.

## LATCHUP CHARACTERISTICS

| Description                                                                                        | Min     | Max              |
|----------------------------------------------------------------------------------------------------|---------|------------------|
| Input voltage with respect to $V_{SS}$ on all pins except I/O pins (including A9, OE#, and RESET#) | -1.0 V  | 12.5 V           |
| Input voltage with respect to $V_{SS}$ on all I/O pins                                             | -1.0 V  | $V_{CC} + 1.0$ V |
| $V_{CC}$ Current                                                                                   | -100 mA | +100 mA          |

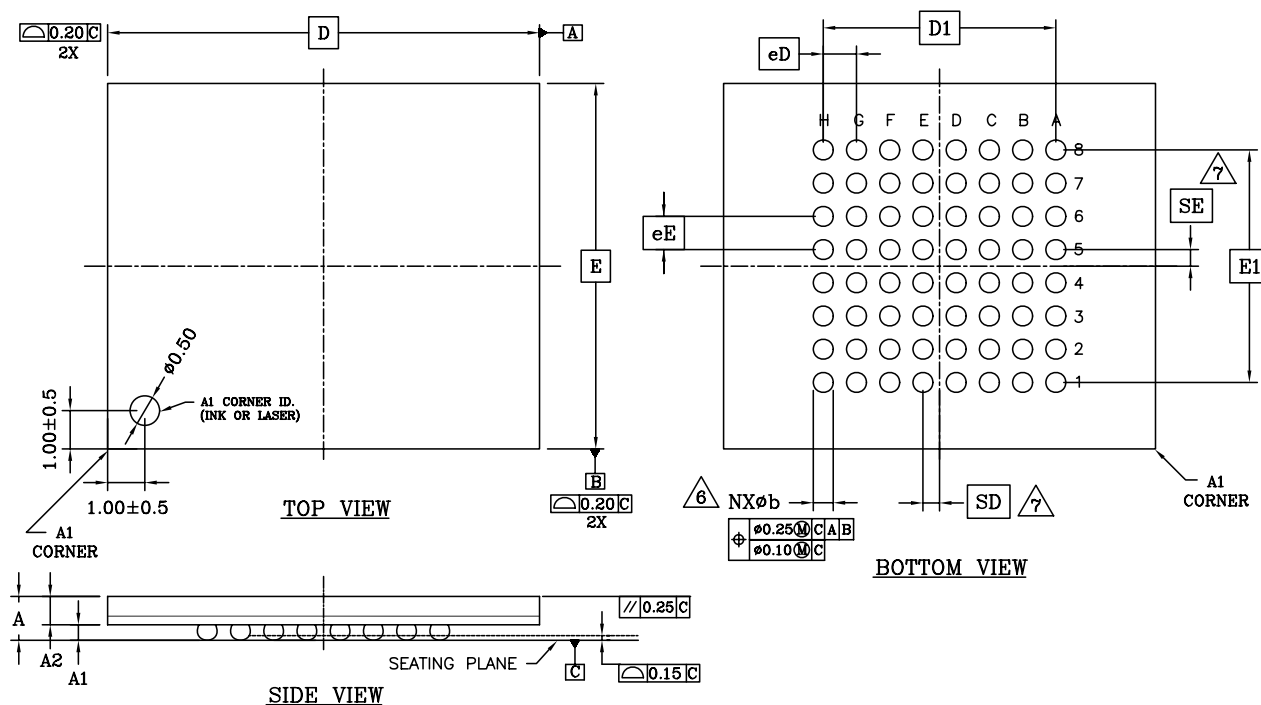
**Note:** Includes all pins except  $V_{CC}$ . Test conditions:  $V_{CC} = 3.0$  V, one pin at a time.

## DATA RETENTION

| Parameter Description               | Test Conditions | Min | Unit  |
|-------------------------------------|-----------------|-----|-------|
| Minimum Pattern Data Retention Time | 150°C           | 10  | Years |
|                                     | 125°C           | 20  | Years |

## PHYSICAL DIMENSIONS

## LSA064—64-Ball Fortified Ball Grid Array (Fortified BGA) 13 x 11 mm package



|         |                           |      |      |                          |
|---------|---------------------------|------|------|--------------------------|
| PACKAGE | XLSA 064                  |      |      | NOTE                     |
| JEDEC   | N/A                       |      |      |                          |
|         | 13.00mm X 11.00mm PACKAGE |      |      |                          |
| SYMBOL  | MIN.                      | NOM. | MAX. |                          |
| A       | ---                       | ---  | 1.70 | PROFILE HEIGHT           |
| A1      | 0.40                      | ---  | ---  | STANDOFF                 |
| A2      | 1.00                      | ---  | ---  | BODY THICKNESS           |
| D       | 13.00 BSC                 |      |      | BODY SIZE                |
| E       | 11.00 BSC                 |      |      | BODY SIZE                |
| D1      | 7.00 BSC                  |      |      | MATRIX FOOTPRINT         |
| E1      | 7.00 BSC                  |      |      | MATRIX FOOTPRINT         |
| MD      | 8                         |      |      | MATRIX SIZE D DIRECTION  |
| ME      | 8                         |      |      | MATRIX SIZE E DIRECTION  |
| n       | 64                        |      |      | BALL COUNT               |
| øb      | 0.50                      | 0.60 | 0.70 | BALL DIAMETER            |
| eD      | 1.00 BSC                  |      |      | BALL PITCH – D DIRECTION |
| eE      | 1.00 BSC                  |      |      | BALL PITCH – E DIRECTION |
| SD/SE   | 0.50 BSC                  |      |      | SOLDER BALL PLACEMENT    |
|         |                           |      |      | DEPOPULATED SOLDER BALLS |

## NOTES:

- DIMENSIONING AND TOLERANCING METHODS PER ASME Y14.5M-1994 .
- ALL DIMENSIONS ARE IN MILLIMETERS .
- BALL POSITION DESIGNATION PER JESD 95-1, SPP-010 (EXCEPT AS NOTED).
- [e] REPRESENTS THE SOLDER BALL GRID PITCH .
- SYMBOL "MD" IS THE BALL MATRIX SIZE IN THE "D" DIRECTION.  
SYMBOL "ME" IS THE BALL COLUMN MATRIX SIZE IN THE "E" DIRECTION.  
N IS THE NUMBER OF POPULATED SOLDER BALL POSITIONS FOR MATRIX SIZE MD X ME.
- DIMENSION "b" IS MEASURED AT THE MAXIMUM BALL DIAMETER IN A PLANE PARALLEL TO DATUM "C".
- SD AND SE ARE MEASURED WITH RESPECT TO DATUMS A AND B AND DEFINE THE POSITION OF THE CENTER SOLDER BALL IN THE OUTER ROW.  
WHEN THERE IS AN ODD NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE = 0.000.  
WHEN THERE IS AN EVEN NUMBER OF SOLDER BALLS IN THE OUTER ROW, SD OR SE =  $e/2$
- "X" IN THE PACKAGE VARIATIONS DENOTES PART IS UNDER QUALIFICATION.
- "+" INDICATES THE THEORETICAL CENTER OF DEPOPULATED BALLS.

## REVISION SUMMARY

### Revision A (August 14, 2001)

Initial release.

### Revision A2 (May 5, 2006)

Updated migration/obsolescence notices.

### Revision A1 (January 7, 2005)

Noted on the cover page and first page of data sheet that the Am29LV642D device has been superseded by the Spansion S29GL128N.

## Colophon

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